

## Low-Power, Low-Noise, 24-Bit, Analog-to-Digital Converter for Small-Signal Sensors

### FEATURES

- **Low Current Consumption:**
  - Duty-Cycle Mode: 120  $\mu\text{A}$
  - Normal Mode: 415  $\mu\text{A}$
- **Wide Supply Range: 2.3 V to 5.5 V**
- **Programmable Gain: 1 V/V to 128 V/V**
- **Programmable Data Rates: Up to 2 kSPS**
- **50-Hz and 60-Hz Rejection at 20 SPS**
- **Low-Noise PGA: 90 nV<sub>RMS</sub> at 20 SPS**
- **Dual Matched Programmable Current Sources:**  
10  $\mu\text{A}$  to 1500  $\mu\text{A}$
- **Internal Temperature Sensor:**  
0.5°C Error (max)
- **Low-Drift Internal Reference**
- **Low-Drift Internal Oscillator**
- **Two Differential or Four Single-Ended Inputs**
- **SPI™-Compatible Interface**
- **3,5 mm × 3,5 mm × 0,9 mm QFN Package**

### APPLICATIONS

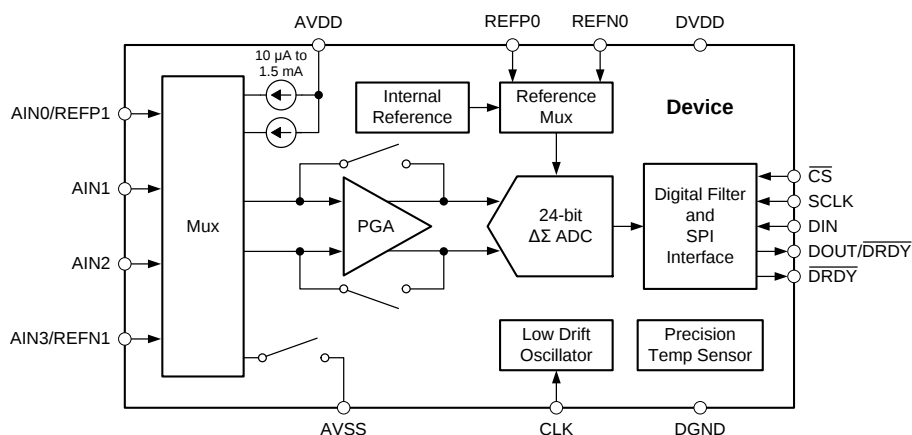
- **Temperature Sensors:**
  - Thermocouples
  - Resistance Temperature Detectors (RTDs)
  - 2-, 3-, and 4-Wire RTD Excitation
- **Bridge Sensors**
- **Portable Instrumentation**
- **Factory Automation and Process Control**

### DESCRIPTION

The ADS1220 is a precision, 24-bit, analog-to-digital converter (ADC) offered in a leadless QFN-16 or a TSSOP-16 package. The device features two differential or four single-ended inputs through a very flexible input multiplexer (mux), a low-noise, programmable gain amplifier (PGA), two programmable excitation current sources, an internal reference, an oscillator, a low-side bridge switch, and a precision temperature sensor. The many integrated features and the simple control of the ADS1220 through an SPI-compatible interface ease precision measurements of the most common sensor signals.

The device can perform conversions at data rates of up to 2000 samples-per-second (SPS) with single-cycle settling. The internal PGA offers gains of up to 128 V/V. This PGA makes the ADS1220 ideally-suited for applications measuring small signals, such as thermocouples, resistance temperature detectors (RTDs), thermistors, and bridge sensors. The device supports true bipolar analog supplies in the event that single-ended signals referenced to ground must be measured using the PGA. Alternatively, the device can be configured to bypass the internal PGA while still providing gains of up to 4 V/V, allowing for rail-to-rail input signals with no loss of signal integrity when running from a single analog supply.

The device operates in either duty-cycle mode (consuming 120  $\mu\text{A}$  of current), normal mode (consuming 415  $\mu\text{A}$  of current), or turbo mode (for highest data rates). The ADS1220 operates over a temperature range of  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ .



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

SPI is a trademark of Motorola, Inc.

All other trademarks are the property of their respective owners.

UNLESS OTHERWISE NOTED this document contains PRODUCTION DATA information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

Copyright © 2013, Texas Instruments Incorporated



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## ORDERING INFORMATION

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at [www.ti.com](http://www.ti.com).

### PRODUCT FAMILY

| DEVICE  | RESOLUTION (Bits) | MAXIMUM GAIN | MAXIMUM SAMPLE RATE (SPS) | PACKAGE DESIGNATOR |
|---------|-------------------|--------------|---------------------------|--------------------|
| ADS1120 | 16                | 128          | 2000                      | QFN-16             |
|         |                   |              |                           | TSSOP-16           |
| ADS1220 | 24                | 128          | 2000                      | QFN-16             |
|         |                   |              |                           | TSSOP-16           |

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

|                                       |                                                                                | VALUE      |            | UNIT |
|---------------------------------------|--------------------------------------------------------------------------------|------------|------------|------|
|                                       |                                                                                | MIN        | MAX        |      |
| AVDD to AVSS                          |                                                                                | –0.3       | +7         | V    |
| DVDD to DGND                          |                                                                                | –0.3       | +7         | V    |
| AVSS to DGND                          |                                                                                | –2.8       | +0.3       | V    |
| Analog input voltage                  | AIN0/REFP1, AIN1, AIN2, AIN3/REFN1, REFP0, REFN0                               | AVSS – 0.3 | AVDD + 0.3 | V    |
| Digital input voltage                 | $\overline{CS}$ , SCLK, DIN, DOUT/ $\overline{DRDY}$ , $\overline{DRDY}$ , CLK | DGND – 0.3 | DVDD + 0.3 | V    |
| Analog input current                  | Momentary                                                                      | –100       | +100       | mA   |
|                                       | Continuous                                                                     | –10        | +10        | mA   |
| Temperature                           | Maximum junction, $T_{JMax}$                                                   |            | +150       | °C   |
|                                       | Storage, $T_{stg}$                                                             | –60        | +150       | °C   |
| Electrostatic discharge (ESD) ratings | Human body model (HBM)<br>JEDEC standard 22, test method A114-C.01, all pins   | –2000      | +2000      | V    |
|                                       | Charged device model (CDM)<br>JEDEC standard 22, test method C101, all pins    | –500       | +500       | V    |

(1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

### THERMAL INFORMATION

| THERMAL METRIC <sup>(1)</sup> |                                              | ADS1220   |            | UNITS |
|-------------------------------|----------------------------------------------|-----------|------------|-------|
|                               |                                              | QFN (RVA) | TSSOP (PW) |       |
|                               |                                              | 16 PINS   | 16 PINS    |       |
| $\theta_{JA}$                 | Junction-to-ambient thermal resistance       | 43.4      | 99.5       | °C/W  |
| $\theta_{JTop}$               | Junction-to-case (top) thermal resistance    | 47.3      | 35.2       |       |
| $\theta_{JB}$                 | Junction-to-board thermal resistance         | 18.4      | 44.3       |       |
| $\psi_{JT}$                   | Junction-to-top characterization parameter   | 0.6       | 2.4        |       |
| $\psi_{JB}$                   | Junction-to-board characterization parameter | 18.4      | 43.8       |       |
| $\theta_{JBot}$               | Junction-to-case (bottom) thermal resistance | 2.0       | n/a        |       |

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/zip/Spra953).

## ELECTRICAL CHARACTERISTICS

Minimum and maximum specifications are at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ . Typical specifications are at  $T_A = +25^{\circ}\text{C}$ .

All specifications are at  $AVDD = 3.3\text{ V}$ ,  $AVSS = 0\text{ V}$ ,  $DVDD = 3.3\text{ V}$ , and  $DR = 20\text{ SPS}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.<sup>(1)</sup>

| PARAMETER                  |                                                                     | TEST CONDITIONS                                                            | MIN                                               | TYP           | MAX            | UNIT                           |
|----------------------------|---------------------------------------------------------------------|----------------------------------------------------------------------------|---------------------------------------------------|---------------|----------------|--------------------------------|
| ANALOG INPUTS              |                                                                     |                                                                            |                                                   |               |                |                                |
|                            | Full-scale differential input voltage range                         | $V_{IN} = (AIN_P - AIN_N)$                                                 | $\pm V_{REF} / PGA^{(2)}$                         |               |                | V                              |
|                            | Absolute input voltage                                              | $AIN_P$ or $AIN_N$ , PGA disabled <sup>(3)</sup>                           | $AVSS - 0.1$                                      |               | $AVDD + 0.1$   | V                              |
| $V_{CM}$                   | Common-mode input voltage range<br>$[V_{CM} = (AIN_P + AIN_N) / 2]$ | PGA disabled <sup>(3)</sup>                                                | $AVSS - 0.1$                                      |               | $AVDD + 0.1$   | V                              |
|                            |                                                                     | PGA = 1...128                                                              | See the <a href="#">Low-Noise PGA</a> section     |               |                |                                |
|                            | Absolute input current                                              |                                                                            | See the <a href="#">Typical Characteristics</a>   |               |                |                                |
|                            | Differential input current                                          |                                                                            | See the <a href="#">Typical Characteristics</a>   |               |                |                                |
| SYSTEM PERFORMANCE         |                                                                     |                                                                            |                                                   |               |                |                                |
|                            | Resolution                                                          | No missing codes                                                           | 24                                                |               |                | Bits                           |
| DR                         | Data rate                                                           | Normal mode                                                                | 20, 45, 90, 175, 330, 600, 1000                   |               |                | SPS                            |
|                            |                                                                     | Duty-cycle mode                                                            | 5, 11.25, 22.5, 44, 82.5, 150, 250                |               |                | SPS                            |
|                            |                                                                     | Turbo mode                                                                 | 40, 90, 180, 350, 660, 1200, 2000                 |               |                | SPS                            |
|                            | Noise (input-referred)                                              |                                                                            | See the <a href="#">Noise Performance</a> section |               |                |                                |
| INL                        | Integral nonlinearity                                               | PGA = 1...128, $V_{CM} = 0.5\text{ AVDD}$ , external reference, best fit   | -15                                               | $\pm 6$       | 15             | ppm                            |
| $V_{IO}$                   | Offset voltage (input-referred)                                     | PGA disabled, $T_A = +25^{\circ}\text{C}$ , differential inputs            |                                                   | $\pm 4$       |                | $\mu\text{V}$                  |
|                            |                                                                     | PGA = 1, $T_A = +25^{\circ}\text{C}$ , differential inputs                 | -30                                               | $\pm 4$       | 30             | $\mu\text{V}$                  |
|                            |                                                                     | PGA = 2...128, $T_A = +25^{\circ}\text{C}$ , differential inputs           |                                                   | $\pm 4$       |                | $\mu\text{V}$                  |
|                            | Offset drift                                                        | PGA = 1...128, $T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}^{(4)}$  |                                                   | 0.08          | 0.3            | $\mu\text{V}/^{\circ}\text{C}$ |
|                            |                                                                     | PGA = 1...128, $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$       |                                                   | 0.25          |                | $\mu\text{V}/^{\circ}\text{C}$ |
|                            | Offset match                                                        | Match between any two inputs                                               |                                                   | $\pm 20$      |                | $\mu\text{V}$                  |
| GE                         | Gain error                                                          | PGA = 1...128, $T_A = +25^{\circ}\text{C}$                                 | -0.1%                                             | $\pm 0.015\%$ | 0.1%           |                                |
|                            | Gain drift                                                          | PGA = 1...128, $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}^{(4)}$ |                                                   | 1             | 4              | ppm/ $^{\circ}\text{C}$        |
| NMRR                       | Normal-mode rejection ratio <sup>(5)</sup>                          | 50 Hz $\pm 3\%$ , DR = 20 SPS, external CLK, bit 50/60 = 10                | 105                                               |               |                | dB                             |
|                            |                                                                     | 60 Hz $\pm 3\%$ , DR = 20 SPS, external CLK, bit 50/60 = 11                | 105                                               |               |                | dB                             |
|                            |                                                                     | 50 Hz or 60 Hz $\pm 3\%$ , DR = 20 SPS, external CLK, Bit 50/60 = '01'     | 90                                                |               |                | dB                             |
| CMRR                       | Common-mode rejection ratio                                         | At dc and PGA = 1                                                          | 90                                                | 105           |                | dB                             |
|                            |                                                                     | $f_{CM} = 50\text{ Hz}$ , DR = 2000 SPS <sup>(4)</sup>                     | 95                                                | 115           |                | dB                             |
|                            |                                                                     | $f_{CM} = 60\text{ Hz}$ , DR = 2000 SPS <sup>(4)</sup>                     | 95                                                | 115           |                | dB                             |
| PSRR                       | Power-supply rejection ratio                                        | $AVDD$ at dc, $V_{CM} = 0.5\text{ AVDD}$ , PGA = 1                         | 80                                                | 105           |                | dB                             |
|                            |                                                                     | $DVDD$ at dc, $V_{CM} = 0.5\text{ AVDD}$ , PGA = 1 <sup>(4)</sup>          | 100                                               | 115           |                | dB                             |
| INTERNAL VOLTAGE REFERENCE |                                                                     |                                                                            |                                                   |               |                |                                |
|                            | Initial accuracy                                                    | $T_A = +25^{\circ}\text{C}$                                                | 2.045                                             | 2.048         | 2.051          | V                              |
|                            | Reference drift                                                     | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}^{(4)}$                |                                                   | 5             | 40             | ppm/ $^{\circ}\text{C}$        |
| VOLTAGE REFERENCE INPUT    |                                                                     |                                                                            |                                                   |               |                |                                |
| $V_{REF}$                  | Reference input range                                               | $V_{REF} = (REFPx - REFNx)$                                                | 0.75                                              | 2.5           | $AVDD$         | V                              |
|                            | Negative reference absolute input                                   | $REFNx$ to $AVSS$                                                          | $AVSS - 0.1$                                      |               | $REFPx - 0.75$ | V                              |
|                            | Positive reference absolute input                                   | $REFPx$ to $AVSS$                                                          | $REFNx + 0.75$                                    |               | $AVDD + 0.1$   | V                              |
|                            | Reference input current                                             | $REFN0 = AVSS$ , $REFP0 = V_{REF}$                                         |                                                   | $\pm 10$      |                | nA                             |

(1) *PGA disabled* means the low-noise PGA is bypassed. Only gains of 1, 2, and 4 are possible in this case with the switched-capacitor input structure. *PGA = 1...128* denotes that the low-noise PGA is enabled and set to the respective gain setting.

(2) Limited to  $[(AVDD - AVSS) - 0.4\text{ V}] / PGA$ , when the PGA is enabled.

(3) See the [Bypassing the PGA](#) section for more information.

(4) Minimum and maximum values are ensured by design and characterization data.

(5) Minimum values are ensured by design.

## ELECTRICAL CHARACTERISTICS (continued)

Minimum and maximum specifications are at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ . Typical specifications are at  $T_A = +25^{\circ}\text{C}$ .

All specifications are at  $AVDD = 3.3\text{ V}$ ,  $AVSS = 0\text{ V}$ ,  $DVDD = 3.3\text{ V}$ , and  $DR = 20\text{ SPS}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.<sup>(1)</sup>

| PARAMETER                          | TEST CONDITIONS                                | MIN                               | TYP        | MAX      | UNIT      |
|------------------------------------|------------------------------------------------|-----------------------------------|------------|----------|-----------|
| EXCITATION CURRENT SOURCES (IDACs) |                                                |                                   |            |          |           |
| Current settings                   |                                                | 10, 50, 100, 250, 500, 1000, 1500 |            |          | μA        |
| Compliance voltage                 | All currents                                   | AVDD – 0.9                        |            |          | V         |
| Accuracy                           | All currents, each IDAC                        | –6%                               | ±1%        | 6%       |           |
| Current match                      | Between IDACs<br>(not valid for 10-μA setting) | ±0.3%                             |            |          |           |
| Temperature drift                  | Each IDAC<br>(not valid for 10-μA setting)     | 50                                |            |          | ppm/°C    |
| Temperature drift matching         | Between IDACs<br>(not valid for 10-μA setting) | 10                                |            |          | ppm/°C    |
| CLOCK SOURCES                      |                                                |                                   |            |          |           |
| Internal oscillator accuracy       | Normal mode                                    | –2%                               | ±1%        | 2%       |           |
| External clock                     | Frequency range                                | 0.5                               | 4.096      | 4.5      | MHz       |
|                                    | Duty cycle                                     | 40%                               |            | 60%      |           |
| TEMPERATURE SENSOR                 |                                                |                                   |            |          |           |
| Temperature sensor resolution      | Conversion resolution                          | 14                                |            |          | Bits      |
|                                    | Temperature resolution                         | 0.03125                           |            |          | °C        |
| Temperature sensor accuracy        | T <sub>A</sub> = 0°C to +75°C                  | –0.5                              | ±0.25      | 0.5      | °C        |
|                                    | T <sub>A</sub> = –40°C to +125°C               | –1                                | ±0.5       | 1        | °C        |
|                                    | vs analog supply voltage                       | 0.0625                            |            |          | 0.25 °C/V |
| LOW-SIDE POWER SWITCH              |                                                |                                   |            |          |           |
| R <sub>ON</sub>                    | On resistance                                  |                                   | 3.5        | 5.5      | Ω         |
|                                    | Current through switch                         |                                   |            | 30       | mA        |
| DIGITAL INPUT/OUTPUT               |                                                |                                   |            |          |           |
| V <sub>IH</sub>                    | High-level input voltage                       |                                   | 0.7 DVDD   | DVDD     | V         |
| V <sub>IL</sub>                    | Low-level input voltage                        |                                   | DGND – 0.3 | 0.3 DVDD | V         |
| V <sub>OH</sub>                    | High-level output voltage                      | I <sub>OH</sub> = 3 mA            | 0.8 DVDD   |          | V         |
| V <sub>OL</sub>                    | Low-level output voltage                       | I <sub>OL</sub> = 3 mA            |            | 0.2 DVDD | V         |
| I <sub>H</sub>                     | Input leakage, high                            | V <sub>IH</sub> = 5.5 V           | –10        | 10       | μA        |
| I <sub>L</sub>                     | Input leakage, low                             | V <sub>IL</sub> = DGND            | –10        | 10       | μA        |

## ELECTRICAL CHARACTERISTICS (continued)

Minimum and maximum specifications are at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ . Typical specifications are at  $T_A = +25^{\circ}\text{C}$ .

All specifications are at  $AVDD = 3.3\text{ V}$ ,  $AVSS = 0\text{ V}$ ,  $DVDD = 3.3\text{ V}$ , and  $DR = 20\text{ SPS}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.<sup>(1)</sup>

| PARAMETER                 |                               | TEST CONDITIONS                  | MIN                           | TYP   | MAX  | UNIT |
|---------------------------|-------------------------------|----------------------------------|-------------------------------|-------|------|------|
| POWER-SUPPLY REQUIREMENTS |                               |                                  |                               |       |      |      |
| V <sub>DD</sub>           | Supply voltage                | Digital                          | DVDD to DGND                  | 2.3   | 5.5  | V    |
|                           |                               | Analog, unipolar                 | AVDD to AVSS, AVSS = DGND     | 2.3   | 5.5  | V    |
|                           |                               | Analog, bipolar                  | AVDD to DGND                  | 2.3   | 2.75 | V    |
|                           |                               |                                  | AVSS to DGND                  | −2.75 | −2.3 | V    |
| I <sub>CC</sub>           | Supply current <sup>(6)</sup> | I <sub>AVDD</sub>                | Power-down mode               | 0.1   | 3    | μA   |
|                           |                               |                                  | Duty-cycle mode, PGA disabled | 65    |      | μA   |
|                           |                               |                                  | Normal mode, PGA disabled     | 240   |      | μA   |
|                           |                               |                                  | Normal mode, PGA = 1...16     | 340   | 490  | μA   |
|                           |                               |                                  | Normal mode, PGA = 32         | 425   |      | μA   |
|                           |                               |                                  | Normal mode, PGA = 64, 128    | 510   |      | μA   |
|                           |                               |                                  | Turbo mode, PGA = 1...16      | 540   |      | μA   |
|                           | I <sub>DVDD</sub>             | Power-down mode                  | 0.3                           | 5     | μA   |      |
|                           |                               | Duty-cycle mode                  | 55                            |       | μA   |      |
|                           |                               | Normal mode                      | 75                            | 110   | μA   |      |
|                           |                               | Turbo mode                       | 95                            |       | μA   |      |
|                           | P <sub>D</sub>                | Power dissipation <sup>(6)</sup> | Duty-cycle mode, PGA disabled | 0.4   |      | mW   |
|                           |                               |                                  | Normal mode, PGA = 1...16     | 1.4   |      | mW   |
| Turbo mode, PGA = 1...16  |                               |                                  | 2.1                           |       | mW   |      |
| TEMPERATURE RANGE         |                               |                                  |                               |       |      |      |
| T <sub>stg</sub>          | Storage temperature           |                                  | −60                           |       | +150 | °C   |
|                           | Specified temperature         |                                  | −40                           |       | +125 | °C   |

(6) Internal voltage reference selected, internal oscillator enabled, both IDACs turned off.

## SPI TIMING CHARACTERISTICS

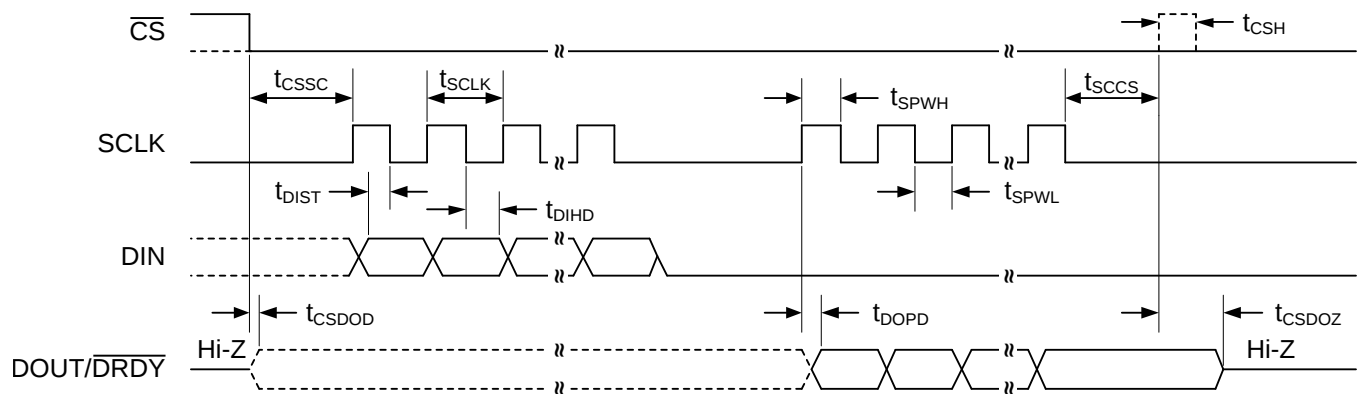


Figure 1. Serial Interface Timing

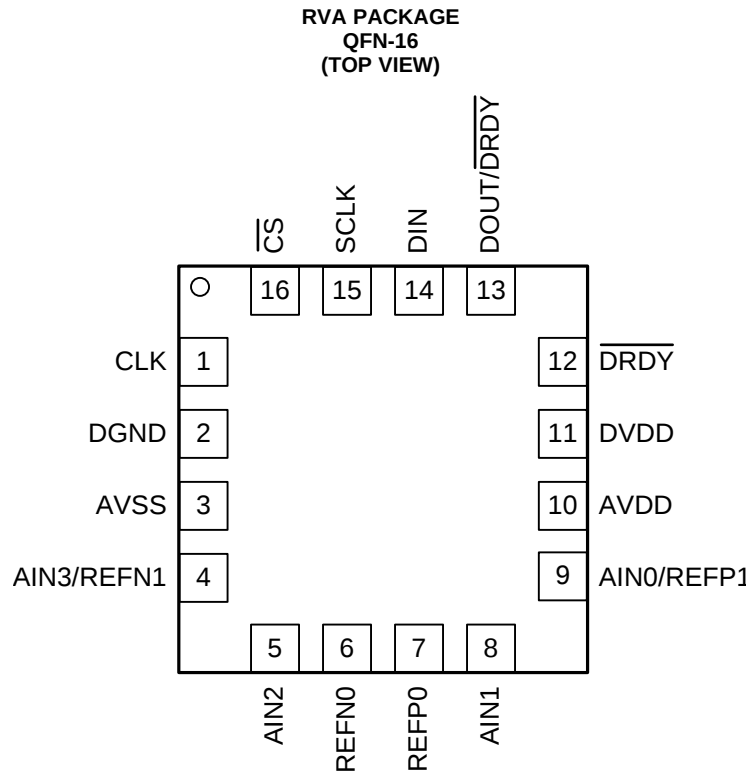
Timing Characteristics for Figure 1<sup>(1)</sup>

| PARAMETER   |                                                                | MIN | MAX | UNIT |
|-------------|----------------------------------------------------------------|-----|-----|------|
| $t_{CSSC}$  | $\overline{CS}$ low to first SCLK high: setup time             | 50  |     | ns   |
| $t_{SCCS}$  | Final SCLK falling edge to $\overline{CS}$ high                | 25  |     | ns   |
| $t_{DIST}$  | DIN setup time                                                 | 50  |     | ns   |
| $t_{DIHD}$  | DIN hold time                                                  | 25  |     | ns   |
| $t_{DOPD}$  | SCLK rising edge to new data valid: propagation delay          | 0   | 50  | ns   |
| $t_{SCLK}$  | SCLK period <sup>(2)</sup>                                     | 150 |     | ns   |
| $t_{SPWH}$  | SCLK pulse width: high <sup>(2)</sup>                          | 60  |     | ns   |
| $t_{SPWL}$  | SCLK pulse width: low <sup>(2)</sup>                           | 60  |     | ns   |
| $t_{CSDOZ}$ | $\overline{CS}$ high to DOUT high impedance: propagation delay |     | 50  | ns   |
| $t_{CSDOD}$ | $\overline{CS}$ low to DOUT driven: propagation delay          |     | 50  | ns   |
| $t_{CSH}$   | $\overline{CS}$ high pulse width                               | 50  |     | ns   |

(1) At  $T_A = -40^\circ\text{C}$  to  $+125^\circ\text{C}$ , DVDD = 2.3 V to 5.5 V, and DOUT load = 20 pF || 10 k $\Omega$  to DGND, unless otherwise noted.

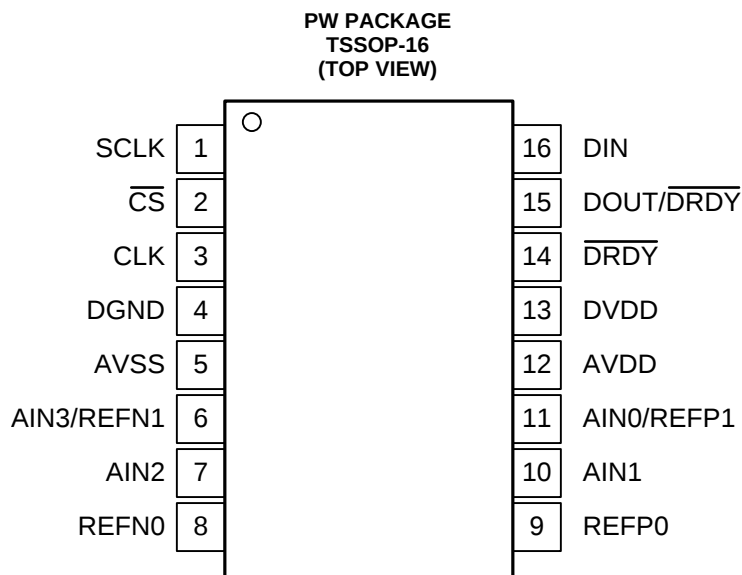
(2) If a complete command is not sent within  $13955 \times t_{MOD}$  (normal mode, duty-cycle mode) or  $27910 \times t_{MOD}$  (turbo mode), respectively, the serial interface resets and the next SCLK pulse starts a new communication cycle.  $t_{MOD} = 1 / f_{MOD}$ . Modulator frequency ( $f_{MOD}$ ) is 256 kHz in normal and duty-cycle mode and 512 kHz in turbo mode when using the internal oscillator or an external 4.096-MHz clock.

## PIN CONFIGURATIONS



## PIN DESCRIPTIONS (QFN PACKAGE)

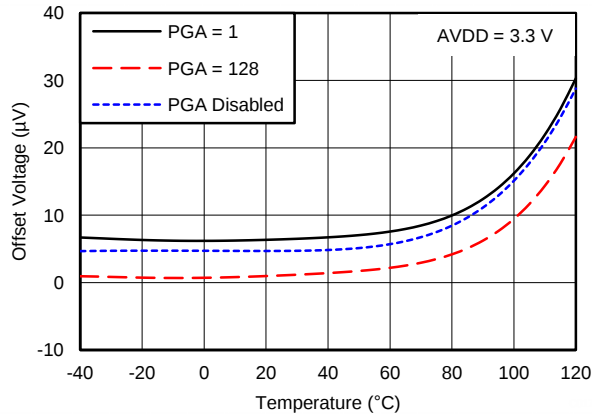
| NAME                           | PIN NO.     | ANALOG OR DIGITAL INPUT/OUTPUT | DESCRIPTION                                                  |
|--------------------------------|-------------|--------------------------------|--------------------------------------------------------------|
| CLK                            | 1           | Digital input                  | External clock source pin; connect to DGND if not used       |
| DGND                           | 2           | Digital                        | Digital ground                                               |
| AVSS                           | 3           | Analog                         | Negative analog power supply                                 |
| AIN3/REFN1                     | 4           | Analog input                   | Differential or single-ended input; negative reference input |
| AIN2                           | 5           | Analog input                   | Differential or single-ended input                           |
| REFN0                          | 6           | Analog input                   | Negative reference input                                     |
| REFPO                          | 7           | Analog input                   | Positive reference input                                     |
| AIN1                           | 8           | Analog input                   | Differential or single-ended input                           |
| AIN0/REFP1                     | 9           | Analog input                   | Differential or single-ended input; positive reference input |
| AVDD                           | 10          | Analog                         | Positive analog power supply                                 |
| DVDD                           | 11          | Digital                        | Positive digital power supply                                |
| $\overline{\text{DRDY}}$       | 12          | Digital output                 | Data ready; active low                                       |
| DOUT/ $\overline{\text{DRDY}}$ | 13          | Digital output                 | Serial data output combined with data ready; active low      |
| DIN                            | 14          | Digital input                  | Serial data input                                            |
| SCLK                           | 15          | Digital input                  | Serial clock input                                           |
| $\overline{\text{CS}}$         | 16          | Digital input                  | Chip select; active low                                      |
| Thermal pad                    | Thermal pad | —                              | Thermal power pad. Do not connect or only connect to AVSS.   |

**PIN DESCRIPTIONS (TSSOP PACKAGE)**

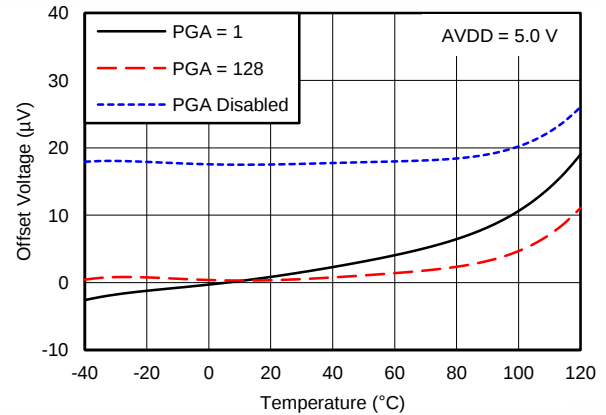
| NAME                           | PIN NO. | ANALOG OR DIGITAL<br>INPUT/OUTPUT | DESCRIPTION                                                  |
|--------------------------------|---------|-----------------------------------|--------------------------------------------------------------|
| SCLK                           | 1       | Digital input                     | Serial clock input                                           |
| $\overline{\text{CS}}$         | 2       | Digital input                     | Chip select; active low                                      |
| CLK                            | 3       | Digital input                     | External clock source pin; connect to DGND if not used       |
| DGND                           | 4       | Digital                           | Digital ground                                               |
| AVSS                           | 5       | Analog                            | Negative analog power supply                                 |
| AIN3/REFN1                     | 6       | Analog input                      | Differential or single-ended input; negative reference input |
| AIN2                           | 7       | Analog input                      | Differential or single-ended input                           |
| REFN0                          | 8       | Analog input                      | Negative reference input                                     |
| REFP0                          | 9       | Analog input                      | Positive reference input                                     |
| AIN1                           | 10      | Analog input                      | Differential or single-ended input                           |
| AIN0/REFP1                     | 11      | Analog input                      | Differential or single-ended input; positive reference input |
| AVDD                           | 12      | Analog                            | Positive analog power supply                                 |
| DVDD                           | 13      | Digital                           | Positive digital power supply                                |
| $\overline{\text{DRDY}}$       | 14      | Digital output                    | Data ready; active low                                       |
| DOUT/ $\overline{\text{DRDY}}$ | 15      | Digital output                    | Serial data output combined with data ready; active low      |
| DIN                            | 16      | Digital input                     | Serial data input                                            |

## TYPICAL CHARACTERISTICS

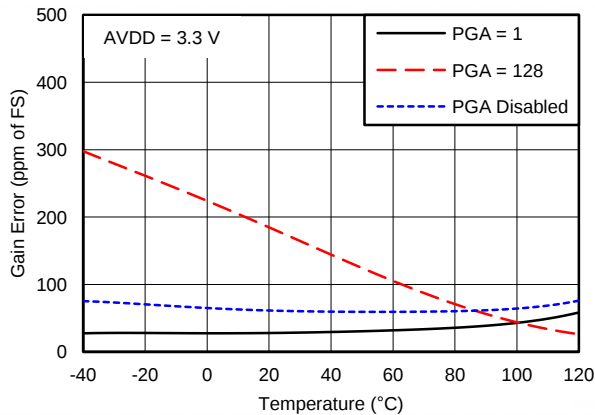
At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.



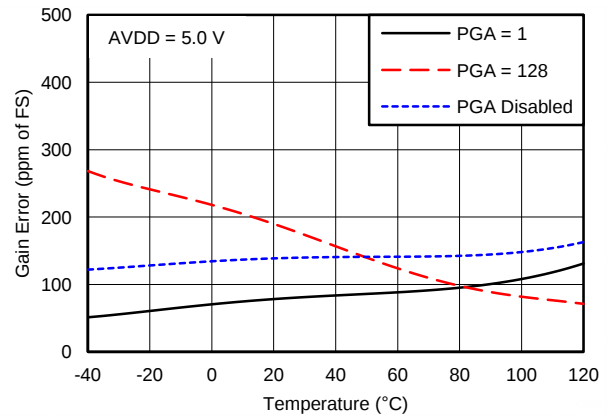
**Figure 2. INPUT-REFERRED OFFSET VOLTAGE vs TEMPERATURE (AVDD = 3.3 V)**



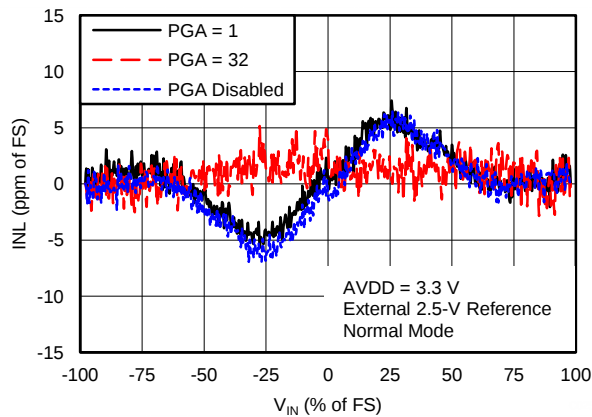
**Figure 3. INPUT-REFERRED OFFSET VOLTAGE vs TEMPERATURE (AVDD = 5.0 V)**



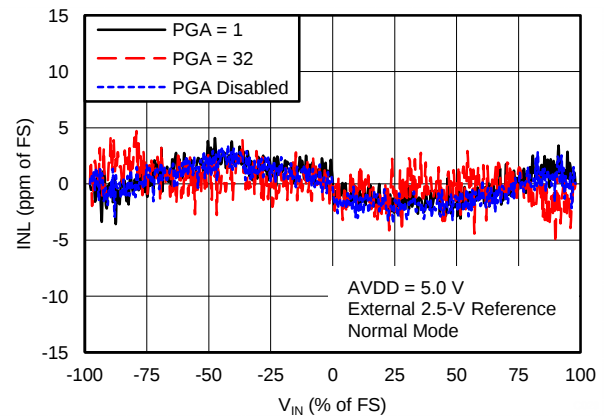
**Figure 4. GAIN ERROR vs TEMPERATURE (AVDD = 3.3 V)**



**Figure 5. GAIN ERROR vs TEMPERATURE (AVDD = 5.0 V)**



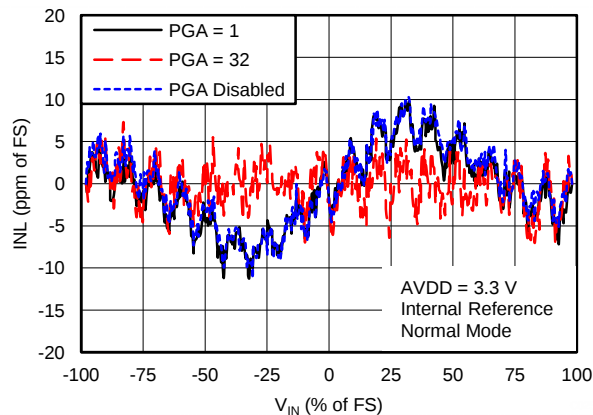
**Figure 6. INTEGRAL NONLINEARITY vs DIFFERENTIAL INPUT SIGNAL (AVDD = 3.3 V, External Reference)**



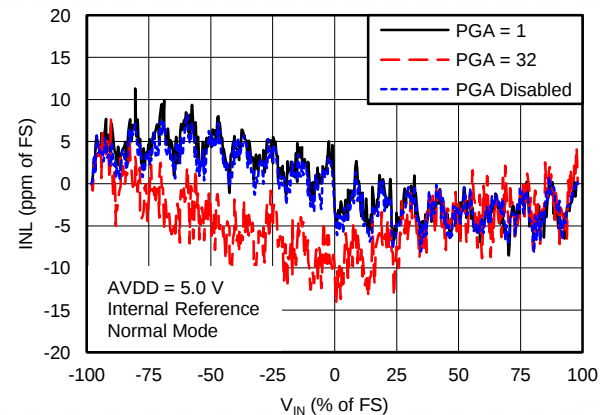
**Figure 7. INTEGRAL NONLINEARITY vs DIFFERENTIAL INPUT SIGNAL (AVDD = 5.0 V, External Reference)**

## TYPICAL CHARACTERISTICS (continued)

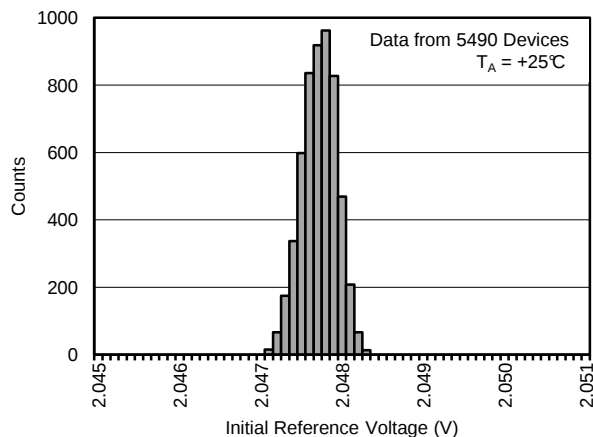
At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.



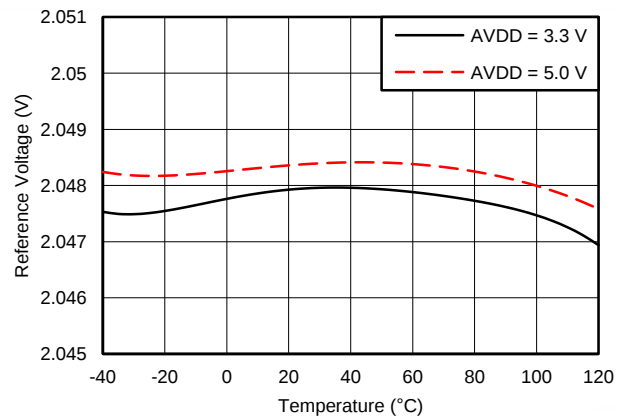
**Figure 8. INTEGRAL NONLINEARITY vs DIFFERENTIAL INPUT SIGNAL (AVDD = 3.3 V, Internal Reference)**



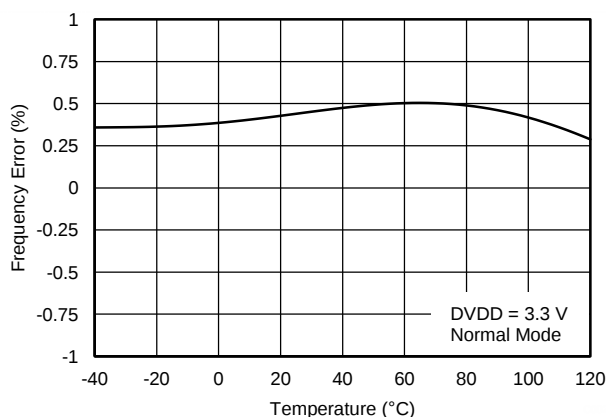
**Figure 9. INTEGRAL NONLINEARITY vs DIFFERENTIAL INPUT SIGNAL (AVDD = 5.0 V, Internal Reference)**



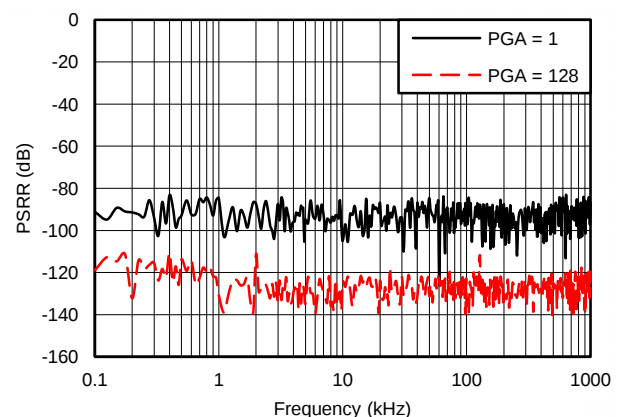
**Figure 10. INTERNAL REFERENCE VOLTAGE HISTOGRAM**



**Figure 11. INTERNAL REFERENCE VOLTAGE vs TEMPERATURE**



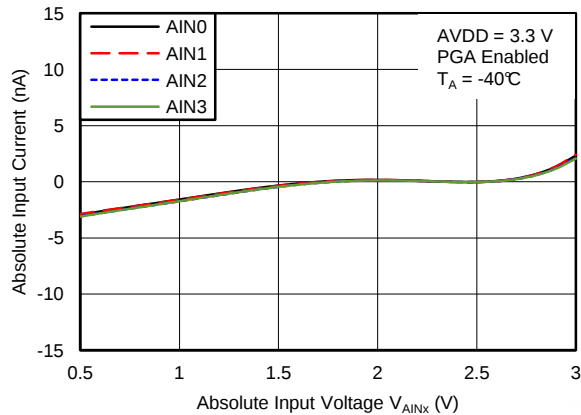
**Figure 12. INTERNAL OSCILLATOR ACCURACY vs TEMPERATURE**



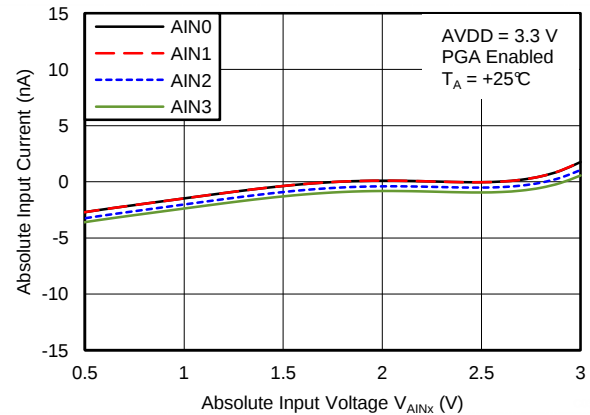
**Figure 13. AVDD POWER-SUPPLY REJECTION RATIO vs FREQUENCY**

## TYPICAL CHARACTERISTICS (continued)

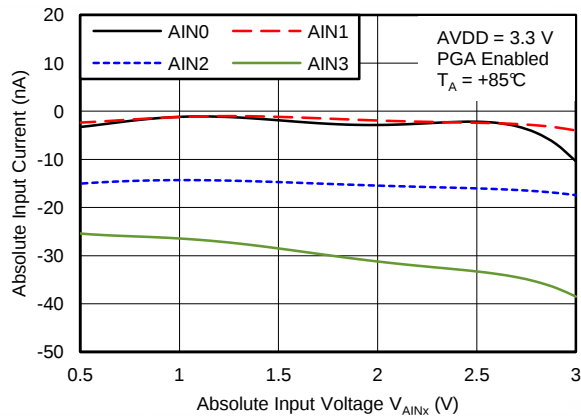
At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.



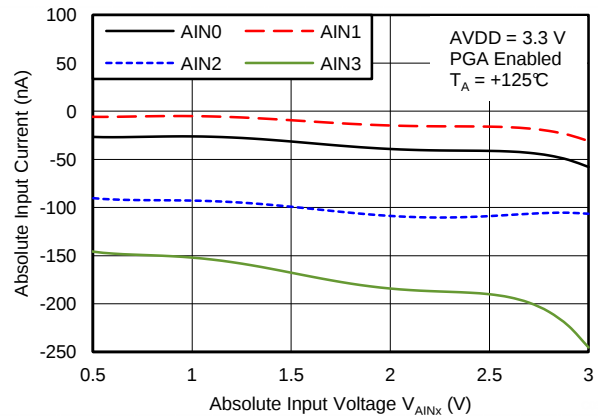
**Figure 14. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Enabled,  $T_A = -40^\circ\text{C}$ )**



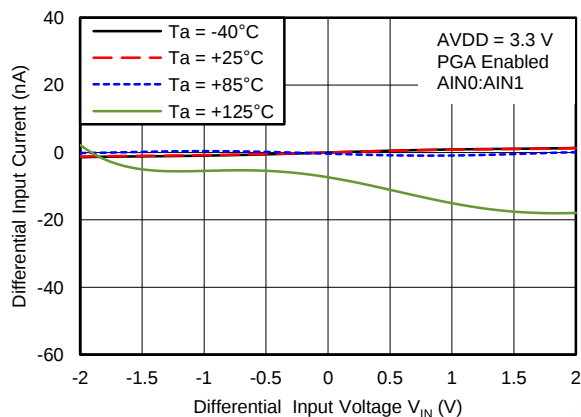
**Figure 15. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Enabled,  $T_A = +25^\circ\text{C}$ )**



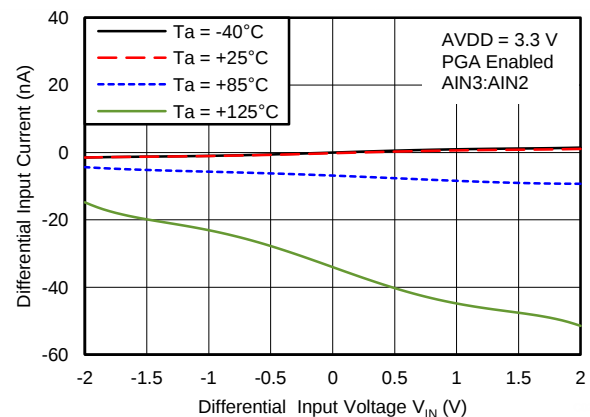
**Figure 16. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Enabled,  $T_A = +85^\circ\text{C}$ )**



**Figure 17. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Enabled,  $T_A = +125^\circ\text{C}$ )**



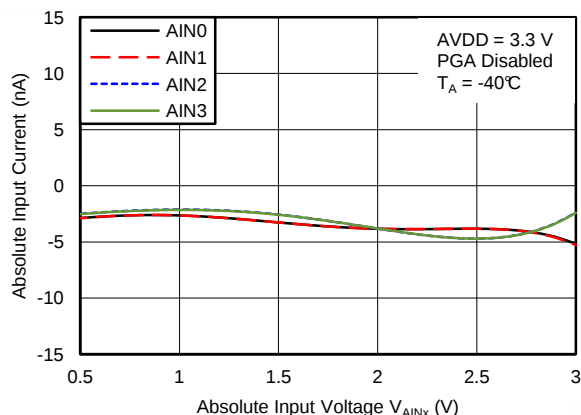
**Figure 18. DIFFERENTIAL INPUT CURRENT vs DIFFERENTIAL INPUT VOLTAGE (PGA Enabled, AIN0:AIN1)**



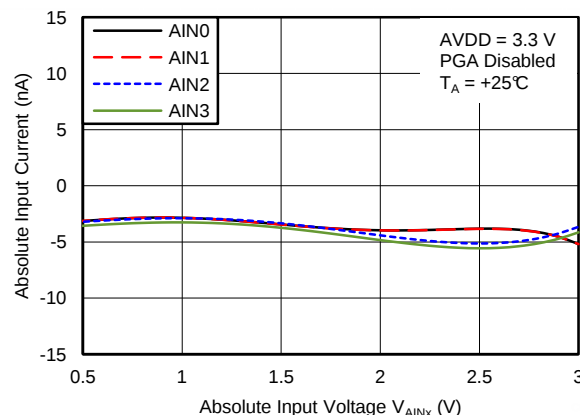
**Figure 19. DIFFERENTIAL INPUT CURRENT vs DIFFERENTIAL INPUT VOLTAGE (PGA Enabled, AIN3:AIN2)**

## TYPICAL CHARACTERISTICS (continued)

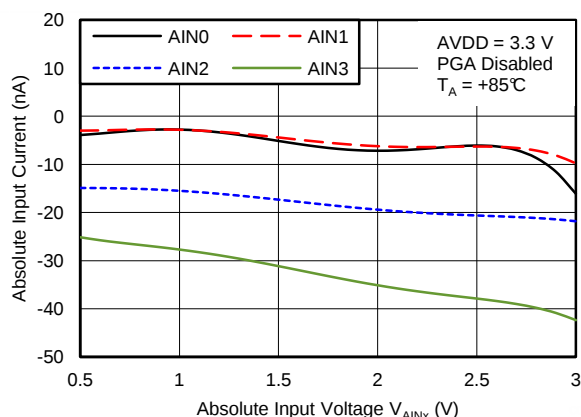
At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.



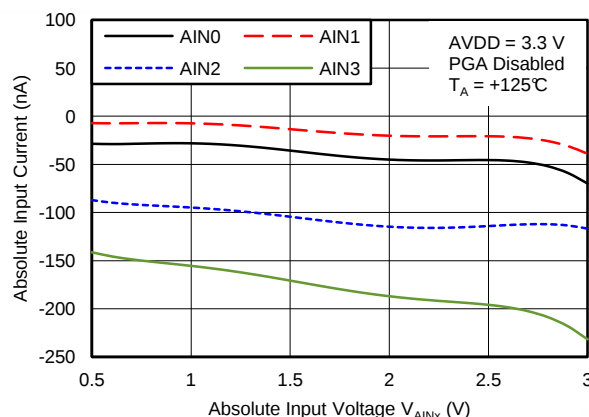
**Figure 20. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Disabled,  $T_A = -40^\circ\text{C}$ )**



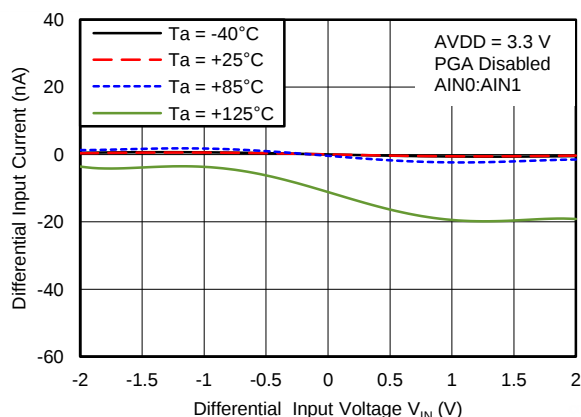
**Figure 21. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Disabled,  $T_A = +25^\circ\text{C}$ )**



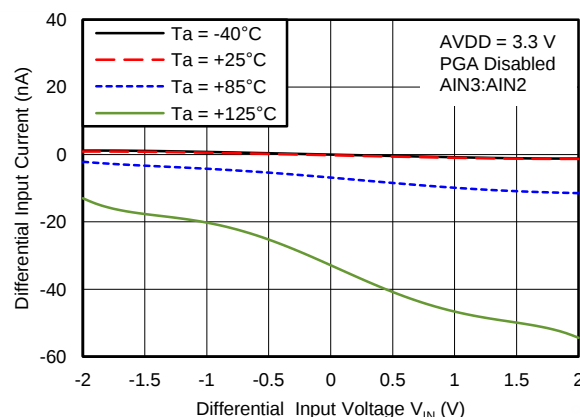
**Figure 22. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Disabled,  $T_A = +85^\circ\text{C}$ )**



**Figure 23. ABSOLUTE INPUT CURRENT vs ABSOLUTE INPUT VOLTAGE (PGA Disabled,  $T_A = +125^\circ\text{C}$ )**



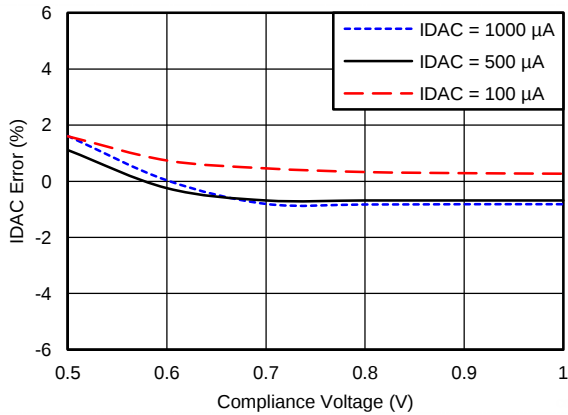
**Figure 24. DIFFERENTIAL INPUT CURRENT vs DIFFERENTIAL INPUT VOLTAGE (PGA Disabled, AIN0:AIN1)**



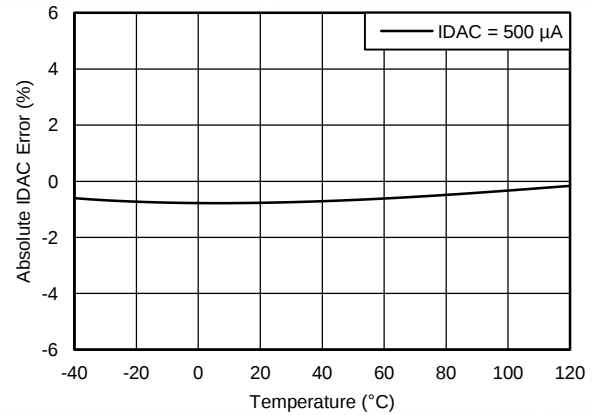
**Figure 25. DIFFERENTIAL INPUT CURRENT vs DIFFERENTIAL INPUT VOLTAGE (PGA Disabled, AIN3:AIN2)**

## TYPICAL CHARACTERISTICS (continued)

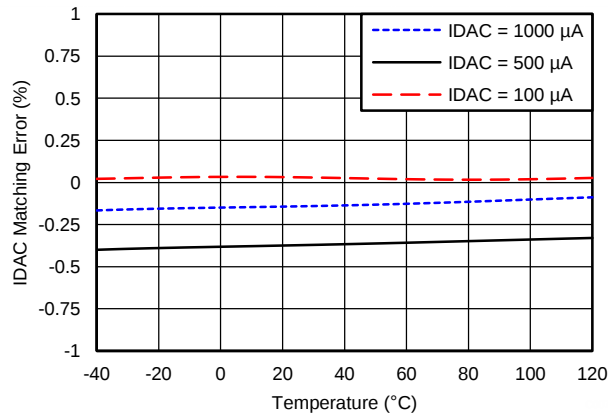
At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.



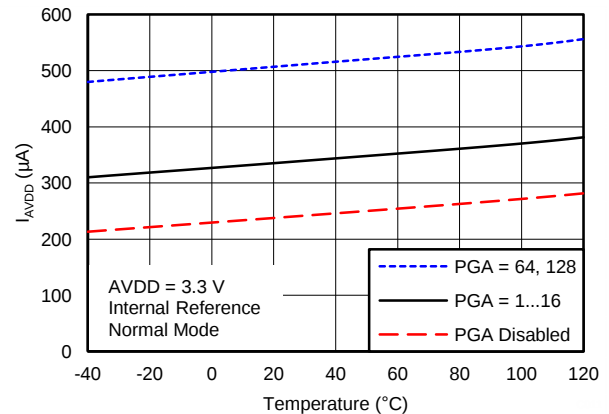
**Figure 26. IDAC ACCURACY vs COMPLIANCE VOLTAGE**



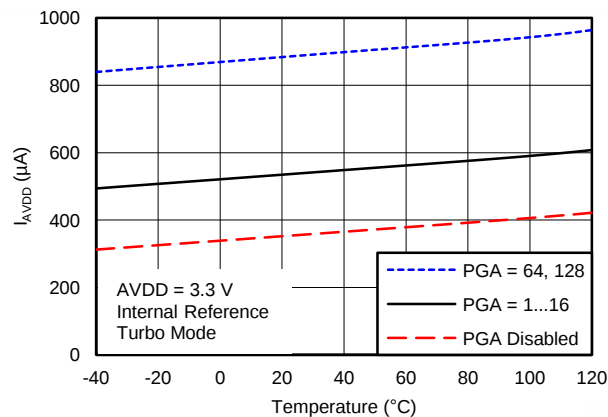
**Figure 27. IDAC ACCURACY vs TEMPERATURE**



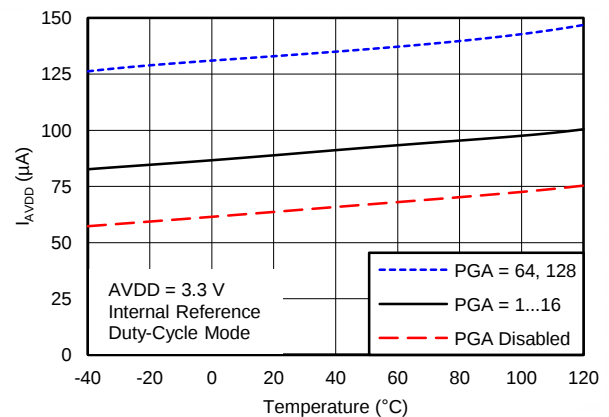
**Figure 28. IDAC MATCHING vs TEMPERATURE**



**Figure 29.  $I_{AVDD}$  vs TEMPERATURE (Normal Mode)**



**Figure 30.  $I_{AVDD}$  vs TEMPERATURE (Turbo Mode)**



**Figure 31.  $I_{AVDD}$  vs TEMPERATURE (Duty-Cycle Mode)**

## TYPICAL CHARACTERISTICS (continued)

At  $T_A = +25^\circ\text{C}$ ,  $AVDD = 3.3\text{ V}$ , and  $AVSS = 0\text{ V}$  using external  $V_{REF} = 2.5\text{ V}$ , unless otherwise noted.

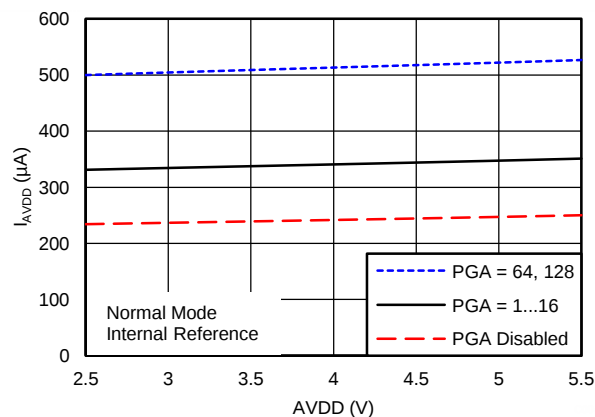


Figure 32.  $I_{AVDD}$  vs  $AVDD$

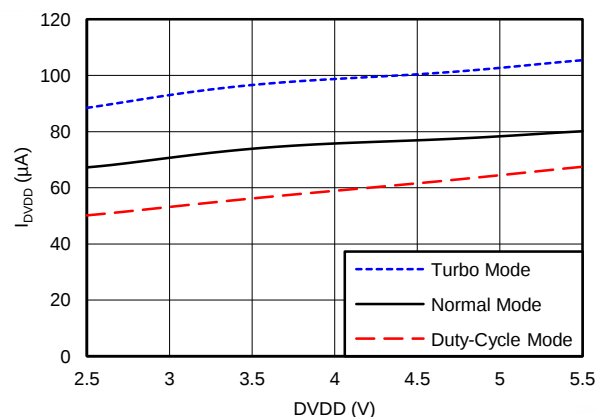


Figure 33.  $I_{DVDD}$  vs  $DVDD$

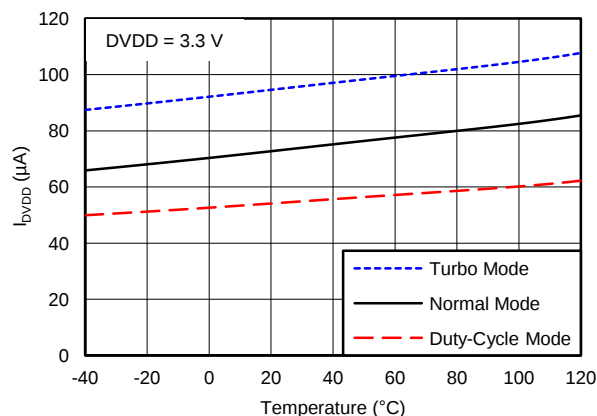


Figure 34.  $I_{DVDD}$  vs TEMPERATURE

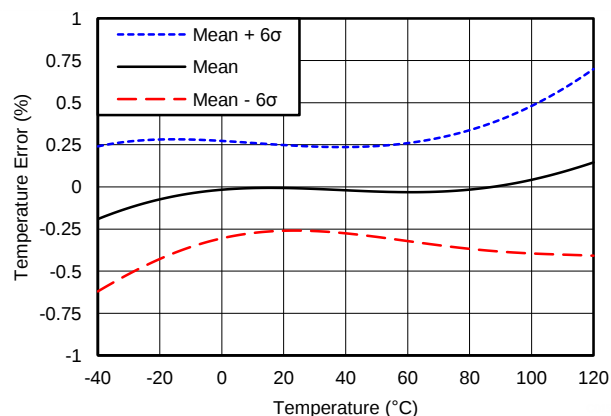


Figure 35. INTERNAL TEMPERATURE SENSOR ACCURACY vs TEMPERATURE

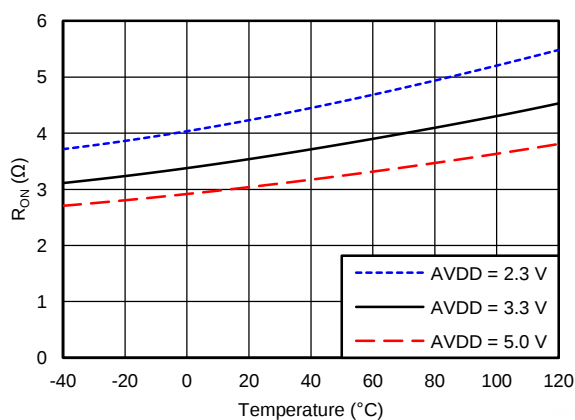


Figure 36. LOW-SIDE POWER SWITCH  $R_{ON}$  vs TEMPERATURE

## NOISE PERFORMANCE

As is the case with any delta-sigma ( $\Delta\Sigma$ ) ADC, noise performance can be optimized by adjusting the output data rate. When reducing the data rate, the input-referred noise drops correspondingly because more samples of the internal modulator are averaged to yield one conversion result. Increasing the gain also reduces the input-referred noise, which is particularly useful when measuring low-level signals. [Table 1](#) to [Table 4](#) summarize the device noise performance. Data are representative of typical noise performance at  $T_A = +25^\circ\text{C}$  with the internal 2.048-V reference. Data shown are the result of averaging readings from a single device over a time period of approximately 0.75 seconds and are measured with the inputs internally shorted together.

[Table 1](#) and [Table 3](#) list the input-referred noise in units of  $\mu\text{V}_{\text{RMS}}$  for the conditions shown. Note that  $\mu\text{V}_{\text{PP}}$  values are shown in parenthesis. [Table 2](#) and [Table 4](#) list the corresponding data in effective number of bits (ENOB) calculated from  $\mu\text{V}_{\text{RMS}}$  values using [Equation 1](#). Note that noise-free bits calculated from peak-to-peak noise values are shown in parenthesis.

The input-referred noise ([Table 1](#) and [Table 3](#)) only changes marginally when using an external low-noise reference, such as the [REF5020](#). To calculate ENOB values when using a reference voltage other than 2.048 V, use [Equation 1](#) and [Equation 2](#):

$$\text{ENOB} = \ln(\text{Full-Scale Range} / \text{Noise}) / \ln(2) \quad (1)$$

$$\text{Full-Scale Range} = 2 \times V_{\text{REF}} / \text{PGA} \quad (2)$$

**Table 1. Noise in  $\mu\text{V}_{\text{RMS}}$  ( $\mu\text{V}_{\text{PP}}$ )  
at AVDD = 3.3 V, AVSS = 0 V, and Internal Reference = 2.048 V**

| DATA<br>RATE<br>(SPS) | GAIN (PGA ENABLED) |                |              |              |              |              |             |             |
|-----------------------|--------------------|----------------|--------------|--------------|--------------|--------------|-------------|-------------|
|                       | 1                  | 2              | 4            | 8            | 16           | 32           | 64          | 128         |
| 20                    | 3.71 (13.67)       | 1.54 (5.37)    | 1.15 (4.15)  | 0.80 (3.36)  | 0.35 (1.16)  | 0.23 (0.73)  | 0.10 (0.35) | 0.09 (0.41) |
| 45                    | 7.36 (29.54)       | 2.93 (13.06)   | 1.71 (9.28)  | 0.88 (4.06)  | 0.50 (2.26)  | 0.29 (1.49)  | 0.19 (0.82) | 0.12 (0.51) |
| 90                    | 10.55 (47.36)      | 4.50 (20.75)   | 2.43 (11.35) | 1.51 (6.65)  | 0.65 (3.62)  | 0.42 (2.14)  | 0.27 (1.22) | 0.18 (0.85) |
| 175                   | 11.90 (63.72)      | 6.45 (34.06)   | 3.26 (17.76) | 1.82 (11.20) | 1.01 (5.13)  | 0.57 (3.09)  | 0.34 (2.14) | 0.26 (1.60) |
| 330                   | 19.19 (106.93)     | 9.38 (50.78)   | 4.25 (26.25) | 2.68 (14.13) | 1.45 (7.52)  | 0.79 (4.66)  | 0.50 (2.69) | 0.34 (1.99) |
| 600                   | 24.78 (151.61)     | 13.35 (72.27)  | 6.68 (39.43) | 3.66 (19.26) | 2.10 (12.77) | 1.14 (6.87)  | 0.70 (4.76) | 0.55 (3.34) |
| 1000                  | 37.53 (227.29)     | 18.87 (122.68) | 9.53 (58.53) | 5.37 (31.52) | 2.95 (18.08) | 1.65 (10.71) | 1.03 (6.52) | 0.70 (4.01) |
| 2000                  | 36.23 (265.14)     | 18.24 (127.32) | 9.24 (65.43) | 5.49 (37.02) | 2.89 (18.89) | 1.77 (12.00) | 1.13 (7.60) | 0.82 (5.81) |

**Table 2. ENOB from RMS Noise (Peak-to-Peak Noise)  
at AVDD = 3.3 V, AVSS = 0 V, and Internal Reference = 2.048 V**

| DATA<br>RATE<br>(SPS) | GAIN (PGA ENABLED) |               |               |               |               |               |               |               |
|-----------------------|--------------------|---------------|---------------|---------------|---------------|---------------|---------------|---------------|
|                       | 1                  | 2             | 4             | 8             | 16            | 32            | 64            | 128           |
| 20                    | 20.08 (18.19)      | 20.34 (18.54) | 19.76 (17.91) | 19.28 (17.22) | 19.48 (17.75) | 19.10 (17.42) | 19.33 (17.49) | 18.49 (16.26) |
| 45                    | 19.09 (17.08)      | 19.42 (17.26) | 19.19 (16.75) | 19.15 (16.94) | 18.95 (16.79) | 18.74 (16.39) | 18.38 (16.25) | 18.00 (15.49) |
| 90                    | 18.57 (16.40)      | 18.80 (16.59) | 18.68 (16.46) | 18.37 (16.23) | 18.60 (16.11) | 18.20 (15.87) | 17.87 (15.67) | 17.44 (15.20) |
| 175                   | 18.39 (15.97)      | 18.28 (15.88) | 18.26 (15.82) | 18.10 (15.48) | 17.96 (15.61) | 17.78 (15.34) | 17.53 (14.87) | 16.91 (14.29) |
| 330                   | 17.70 (15.23)      | 17.74 (15.30) | 17.88 (15.25) | 17.54 (15.15) | 17.43 (15.05) | 17.30 (14.74) | 16.96 (14.54) | 16.50 (13.97) |
| 600                   | 17.33 (14.72)      | 17.23 (14.79) | 17.23 (14.66) | 17.09 (14.70) | 16.89 (14.29) | 16.77 (14.18) | 16.48 (13.72) | 15.83 (13.23) |
| 1000                  | 16.74 (14.14)      | 16.73 (14.03) | 16.71 (14.09) | 16.54 (13.99) | 16.41 (13.79) | 16.25 (13.54) | 15.92 (13.26) | 15.49 (12.96) |
| 2000                  | 16.79 (13.92)      | 16.78 (13.97) | 16.76 (13.93) | 16.51 (13.76) | 16.44 (13.73) | 16.14 (13.38) | 15.79 (13.04) | 15.25 (12.43) |

**Table 3. Noise in  $\mu\text{V}_{\text{RMS}}$  ( $\mu\text{V}_{\text{PP}}$ ) with PGA Disabled  
at AVDD = 3.3 V, AVSS = 0 V, and Internal Reference = 2.048 V**

| DATA RATE<br>(SPS) | GAIN (PGA DISABLED) |                |              |
|--------------------|---------------------|----------------|--------------|
|                    | 1                   | 2              | 4            |
| 20                 | 3.89 (13.43)        | 1.85 (6.84)    | 1.26 (3.91)  |
| 45                 | 6.97 (31.98)        | 2.94 (12.94)   | 1.41 (5.62)  |
| 90                 | 8.50 (42.48)        | 4.49 (18.92)   | 2.07 (9.95)  |
| 175                | 12.99 (65.92)       | 6.24 (35.40)   | 3.04 (18.92) |
| 330                | 18.18 (94.24)       | 8.12 (50.17)   | 4.71 (28.75) |
| 600                | 25.29 (138.67)      | 12.77 (78.13)  | 6.27 (39.79) |
| 1000               | 38.04 (260.50)      | 18.40 (120.97) | 9.48 (63.72) |
| 2000               | 36.11 (250.98)      | 17.30 (131.35) | 8.77 (68.18) |

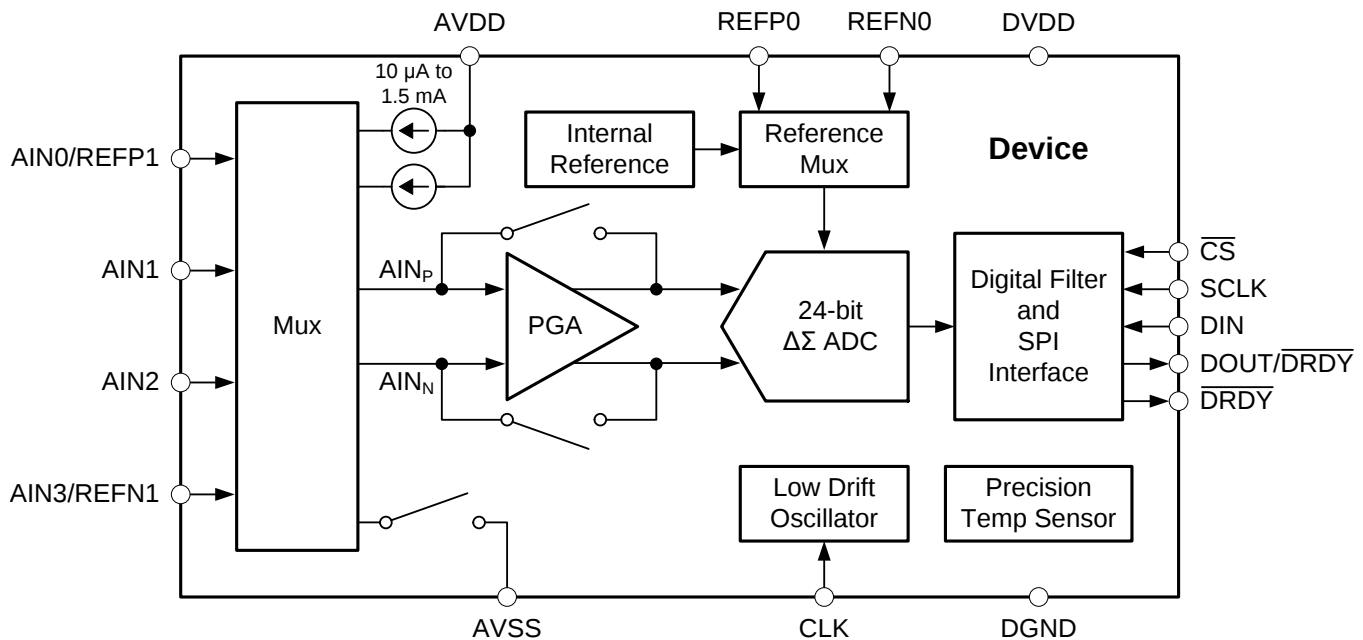
**Table 4. ENOB from RMS Noise (Peak-to-Peak Noise) with PGA Disabled  
at AVDD = 3.3 V, AVSS = 0 V, and Internal Reference = 2.048 V**

| DATA RATE<br>(SPS) | GAIN (PGA DISABLED) |               |               |
|--------------------|---------------------|---------------|---------------|
|                    | 1                   | 2             | 4             |
| 20                 | 20.01 (18.22)       | 20.08 (18.19) | 19.63 (18.00) |
| 45                 | 19.61 (16.97)       | 19.41 (17.27) | 19.47 (17.48) |
| 90                 | 18.88 (16.56)       | 18.80 (16.72) | 18.91 (16.65) |
| 175                | 18.27 (15.92)       | 18.32 (15.82) | 18.36 (15.72) |
| 330                | 17.78 (15.41)       | 17.94 (15.32) | 17.73 (15.12) |
| 600                | 17.31 (14.85)       | 17.29 (14.68) | 17.32 (14.65) |
| 1000               | 16.72 (13.94)       | 16.76 (14.05) | 16.72 (13.97) |
| 2000               | 16.79 (13.99)       | 16.85 (13.93) | 16.83 (13.87) |

## OVERVIEW

The ADS1220 is a small, low-power, 24-bit, highly-integrated,  $\Delta\Sigma$  analog-to-digital converter (ADC). The device is easy to configure and design into a wide variety of applications and allows precise measurements to be obtained with little effort.

In addition to the  $\Delta\Sigma$  ADC core and single-cycle settling digital filter, the ADS1220 offers a low-noise, high input impedance, programmable gain amplifier (PGA), an internal voltage reference, a clock oscillator, and an SPI-compatible interface. The device also integrates a highly linear and accurate temperature sensor as well as two matched programmable current sources (IDACs) for sensor excitation. All of these features are intended to reduce the required external circuitry in typical sensor applications and improve overall system performance. An additional low-side power switch eases the design of low-power bridge sensor applications. Figure 37 shows the ADS1220 functional block diagram.



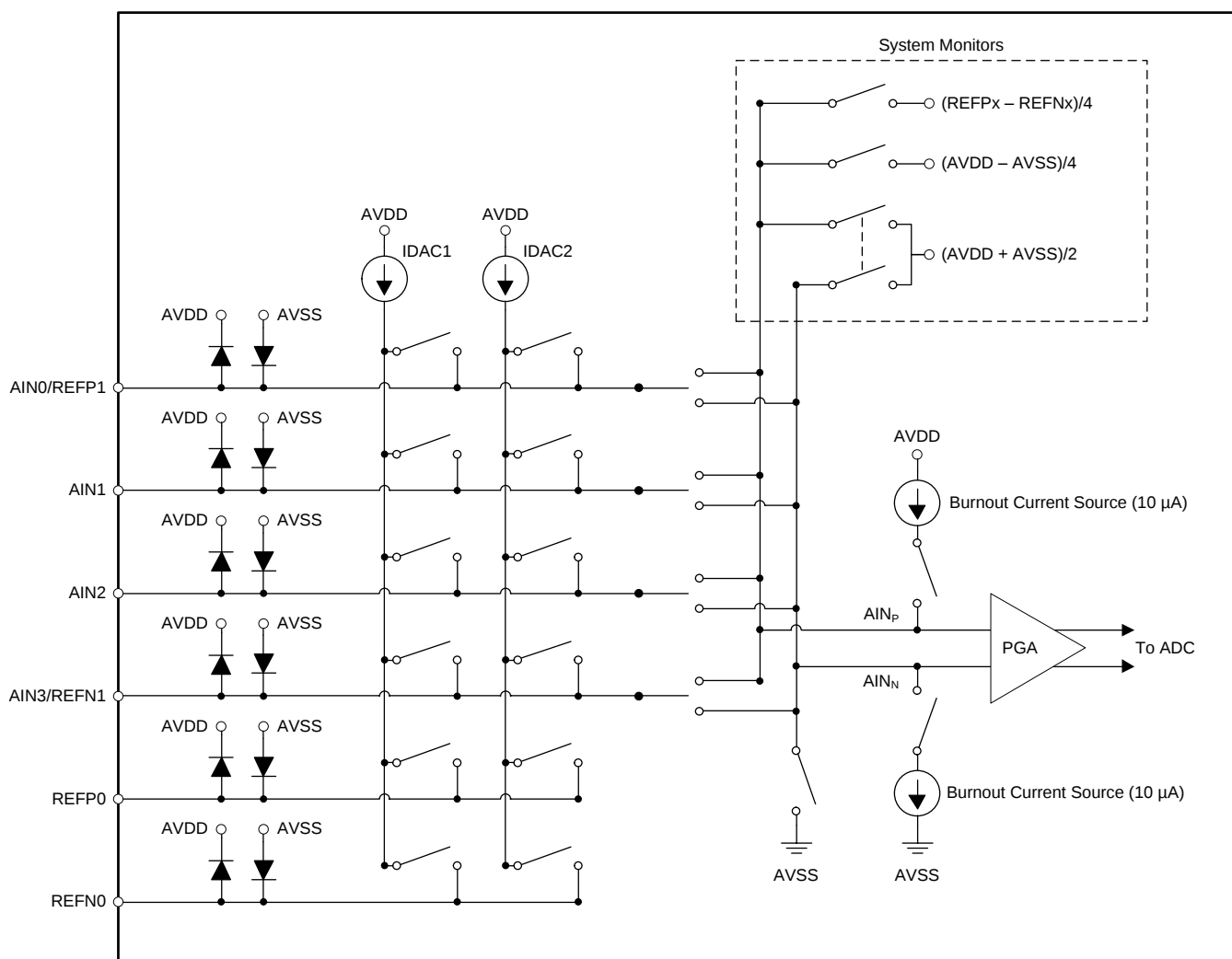
**Figure 37. Functional Block Diagram**

The ADS1220 ADC measures a differential signal,  $V_{IN}$ , which is the difference of  $AIN_P$  and  $AIN_N$ . The converter core consists of a differential, switched-capacitor  $\Delta\Sigma$  modulator followed by a digital filter. The digital filter receives a high-speed bitstream from the modulator and outputs a code proportional to the input voltage. This architecture results in a very strong attenuation in any common-mode signals.

The device has two available conversion modes: single-shot and continuous conversion mode. In single-shot mode, the ADC performs one conversion of the input signal upon request and stores the value to an internal data buffer. The device then enters a low-power state to save power. Single-shot mode is intended to provide significant power savings in systems that require only periodic conversions or when there are long idle periods between conversions. In continuous conversion mode, the ADC automatically begins a conversion of the input signal as soon as the previous conversion is completed. New data are available at the programmed data rate. Data can be read at any time without concern of data corruption and always reflect the most recently completed conversion.

## MULTIPLEXER

The device contains a very flexible input multiplexer, as shown in [Figure 38](#). Either four single-ended signals, two differential signals, or a combination of two single-ended signals and one differential signal can be measured. The multiplexer is configured by four bits (MUX[3:0]) in the configuration register. When single-ended signals are measured, the ADC negative input is internally connected to AVSS by a switch within the multiplexer. For system-monitoring purposes, the analog supply (AVDD – AVSS) / 4 or the currently-selected external reference (REFPx – REFNx) / 4 can be selected as inputs to the ADC. The multiplexer also offers the possibility to route any of the two programmable current sources to any analog input (AINx) or to any dedicated reference pin (REFP0, REFN0).



**Figure 38. Analog Input Multiplexer**

Electrostatic discharge (ESD) diodes to AVDD and AVSS protect the inputs. To prevent the ESD diodes from turning on, the absolute voltage on any input must stay within the range of [Equation 3](#):

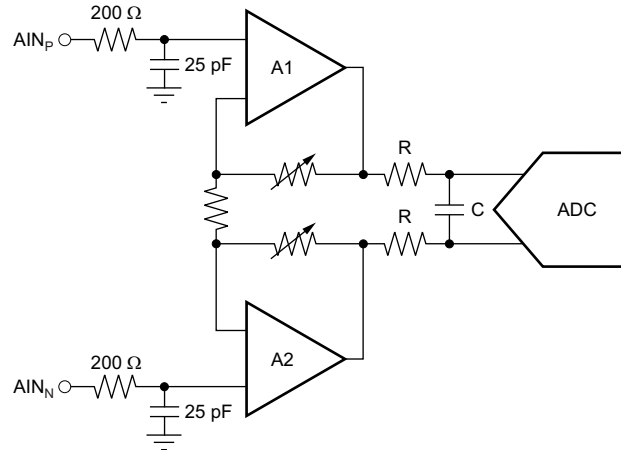
$$AVSS - 0.3 \text{ V} < AINx < AVDD + 0.3 \text{ V} \quad (3)$$

If the voltages on the input pins have any potential to violate these conditions, external Schottky clamp diodes or series resistors may be required to limit the input current to safe values (see the [Absolute Maximum Ratings](#) table). Although the analog inputs can support signals marginally above supply, under no circumstances should any analog or digital input or output be driven to greater than 5.5 V with respect to the GND pin.

Overdriving an unused input on the device may affect conversions taking place on other input pins. If any overdrive on unused inputs is possible, TI recommends clamping the signal with external Schottky diodes.

## LOW-NOISE PGA

The device features a low-noise, low-drift, high input impedance, programmable gain amplifier (PGA). The PGA can be set to gains of 1, 2, 4, 8, 16, 32, 64, or 128. Three bits (GAIN[2:0]) in the configuration register are used to configure the gain. A simplified diagram of the PGA is shown in Figure 39. The PGA consists of two chopper-stabilized amplifiers (A1 and A2) and a resistor feedback network that sets the PGA gain. The PGA input is equipped with an electromagnetic interference (EMI) filter.



**Figure 39. Simplified Diagram of the PGA**

The differential full-scale (FS) input voltage range of the PGA is defined by the gain setting and the reference voltage used, as shown in Equation 4:

$$FS = \pm V_{REF} / PGA \quad (4)$$

Table 5 shows the corresponding full-scale ranges when using the internal 2.048-V reference.

**Table 5. PGA Full-Scale Range**

| GAIN SETTING | FS       |
|--------------|----------|
| 1            | ±2.048 V |
| 2            | ±1.024 V |
| 4            | ±0.512 V |
| 8            | ±0.256 V |
| 16           | ±0.128 V |
| 32           | ±0.064 V |
| 64           | ±0.032 V |
| 128          | ±0.016 V |

Note that as with any PGA, the input voltage must remain within a specified common-mode input voltage range. The common-mode input voltage ( $V_{CM}$ ) must stay within the minimum and maximum limits given by Equation 5 and Equation 6:

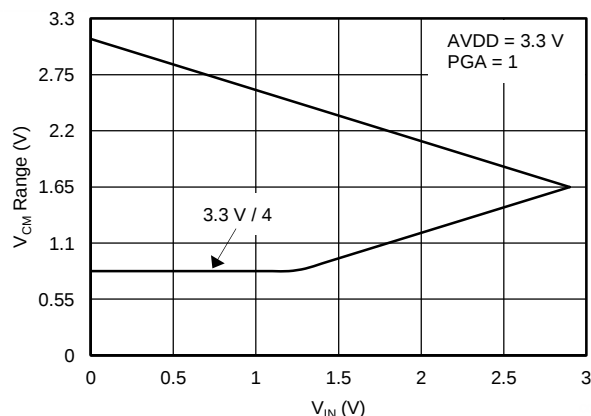
$$V_{CM(MIN)} \geq \left[ AVSS + 0.2 V + \frac{V_{IN} \times PGA}{2} \right] \quad \text{and} \quad V_{CM(MIN)} \geq \left[ AVSS + \frac{AVDD - AVSS}{4} \right] \quad (5)$$

$$V_{CM(MAX)} \leq \left[ AVDD - 0.2 V - \frac{V_{IN} \times PGA}{2} \right] \quad (6)$$

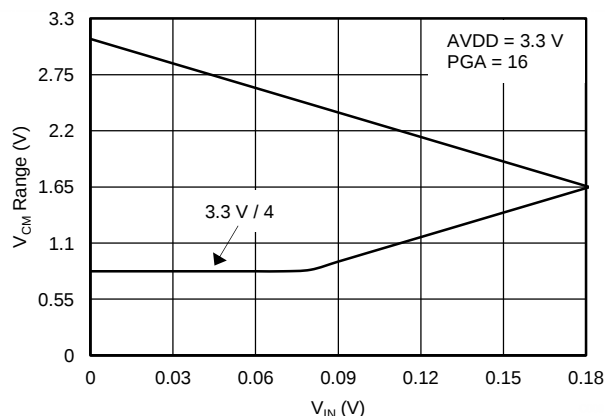
where:

- $V_{CM} = (AIN_P + AIN_N) / 2$ ,
- $PGA =$  PGA gain, and
- $V_{IN}$  = the maximum differential input voltage ( $AIN_P - AIN_N$ ) in the application, which is limited to  $[(AIN_P - AIN_N) \leq \pm V_{REF} / PGA]$ .

Figure 40 and Figure 41 show a graphical representation of the common-mode voltage limits for  $AVDD = 3.3\text{ V}$ ,  $PGA = 1$  and  $PGA = 16$ , respectively.



**Figure 40. Common-Mode Voltage Limits**  
( $AVDD = 3.3\text{ V}$ ,  $PGA = 1$ )



**Figure 41. Common-Mode Voltage Limits**  
( $AVDD = 3.3\text{ V}$ ,  $PGA = 16$ )

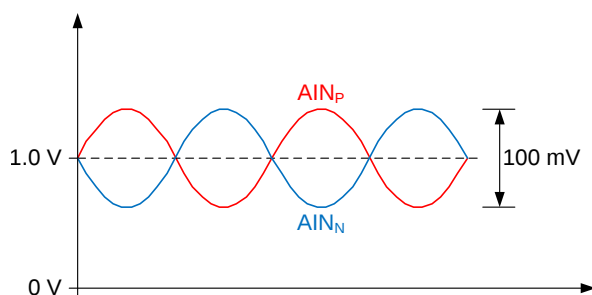
The following paragraphs explain how to apply Equation 5 and Equation 6 to a hypothetical application. The setup for this example is  $AVDD = 3.3\text{ V}$ ,  $AVSS = 0\text{ V}$ , and  $PGA = 16$ , using an external reference  $V_{REF} = 2.5\text{ V}$ . The maximum differential input voltage  $V_{IN} = (AIN_P - AIN_N)$  that can be applied is then limited to the full-scale range of  $FS = \pm 2.5\text{ V} / 16 = \pm 0.156\text{ V}$ . Equation 5 and Equation 6 then yield an allowed  $V_{CM}$  range of  $1.45\text{ V} \leq V_{CM} \leq 1.85\text{ V}$ .

However, the sensor signal that is connected to the inputs in this example application does not make use of the entire full-scale range but is limited to  $V_{IN} = \pm 0.1\text{ V}$ . Accordingly, this reduced input signal relaxes the  $V_{CM}$  restriction to  $1.0\text{ V} \leq V_{CM} \leq 2.3\text{ V}$ .

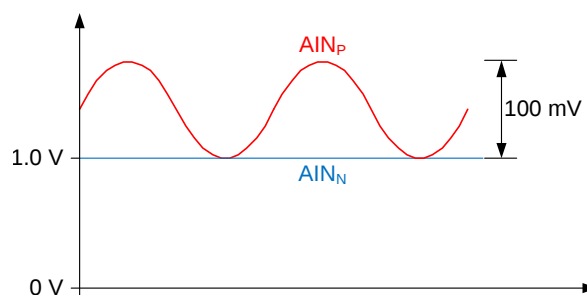
In the case of a fully-differential sensor signal, each input ( $AIN_P$ ,  $AIN_N$ ) can swing up to  $\pm 50\text{ mV}$  around the center voltage  $(AIN_P + AIN_N) / 2$ , which must remain between the common-mode voltage limits of  $1.0\text{ V}$  and  $2.3\text{ V}$ . The output of a symmetrical wheatstone bridge is an example of a fully-differential signal.

In contrast, the signal of an RTD is of a pseudo-differential nature (depending on the circuit implementation), where the negative input is held at a constant voltage other than  $0\text{ V}$ . When a pseudo-differential signal must be measured, the negative input must be biased at a voltage between  $1.0\text{ V}$  and  $2.25\text{ V}$ . The positive input can then swing up to  $100\text{ mV}$  above the negative input.

Figure 42 and Figure 43 illustrate both fully-differential and pseudo-differential cases for this specific example, respectively.



**Figure 42. Fully-Differential Input Signal**



**Figure 43. Pseudo-Differential Input Signal**

## BYPASSING THE PGA

At gains of 1, 2, and 4, the ADS1220 can be configured to disable and bypass the low-noise PGA. Disabling the PGA lowers the overall power consumption and also removes the restrictions of [Equation 5](#) and [Equation 6](#) for the common-mode input voltage range,  $V_{CM}$ . The usable absolute and common-mode input voltage range is  $(AVSS - 0.1\text{ V} \leq V_{CM} \leq AVDD + 0.1\text{ V})$  when the PGA is disabled. In order to measure single-ended signals that are referenced to AVSS ( $VIN_P = VIN$ ,  $VIN_N = AVSS$ ), the PGA must be turned off.

---

### NOTE

When measuring single-ended inputs, the negative range of the output codes is not used. These codes are for measuring negative differential signals, such as  $(AIN_P - AIN_N) < 0\text{ V}$ . Consequently, one bit of resolution is lost because only half of the full-scale range is used.

---

When the PGA is disabled by setting the PGA\_BYPASS bit in the configuration register, the device uses a buffered switched-capacitor stage to obtain gains 1, 2, and 4. An internal buffer in front of the switched-capacitor stage ensures that the impact on the input loading as a result of the capacitors charging and discharging is minimal. Refer to [Figure 20](#) to [Figure 25](#) for the typical values of absolute (current flowing into or out of each input) and differential (difference in absolute current between positive and negative input) input currents when the PGA is disabled.

For signal sources with high output impedance, external buffering may still be necessary. Note that active buffers introduce noise and also introduce offset and gain errors. All of these factors should be considered in high-accuracy applications.

## MODULATOR

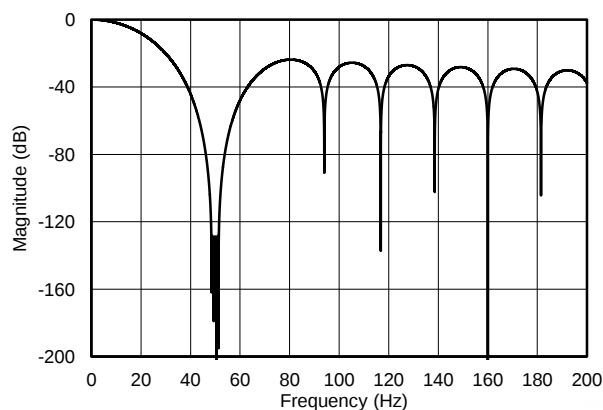
A  $\Delta\Sigma$  modulator is used in the ADS1220 to convert the analog input voltage into a pulse code modulated (PCM) data stream. The modulator runs at a modulator clock frequency of  $f_{\text{MOD}} = f_{\text{CLK}} / 16$  in normal and duty-cycle mode and  $f_{\text{MOD}} = f_{\text{CLK}} / 8$  in turbo mode, where  $f_{\text{CLK}}$  is either provided by the internal oscillator or the external clock source. Table 6 shows the modulator frequency for each mode using either the internal oscillator or an external clock of 4.096 MHz.

**Table 6. Modulator Clock Frequency for Different Operating Modes using the Internal Oscillator**

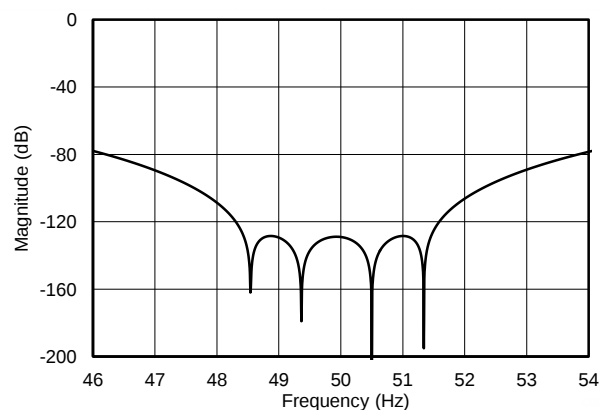
| OPERATING MODE  | $f_{\text{MOD}}$ |
|-----------------|------------------|
| Duty-cycle mode | 256 kHz          |
| Normal mode     | 256 kHz          |
| Turbo mode      | 512 kHz          |

## DIGITAL FILTER

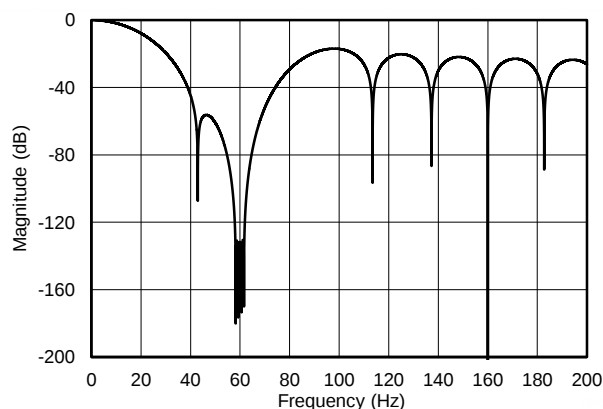
The device uses a linear-phase finite impulse response (FIR) digital filter that performs both filtering and decimation of the digital data stream coming from the modulator. The digital filter is automatically adjusted for the different data rates and always settles within a single cycle. Only at data rates of 5 SPS and 20 SPS can the filter be configured to reject 50-Hz or 60-Hz line frequencies or to simultaneously reject 50 Hz and 60 Hz. Two bits (50/60[1:0]) in the configuration register are used to configure the filter accordingly. The frequency responses of the digital filter are shown in Figure 44 to Figure 47 for different output data rates using the internal oscillator.



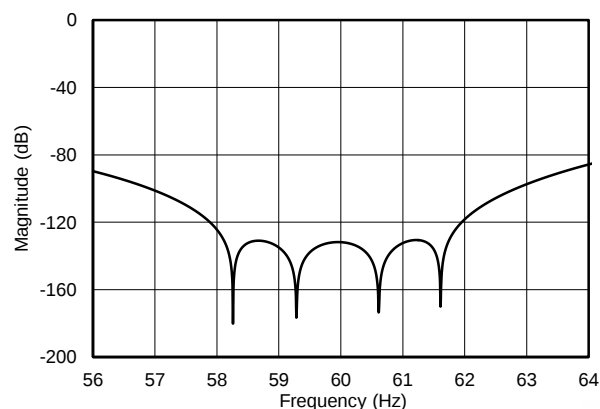
**Figure 44. Filter Response  
(Data Rate = 20 SPS, 50-Hz Rejection Only)**



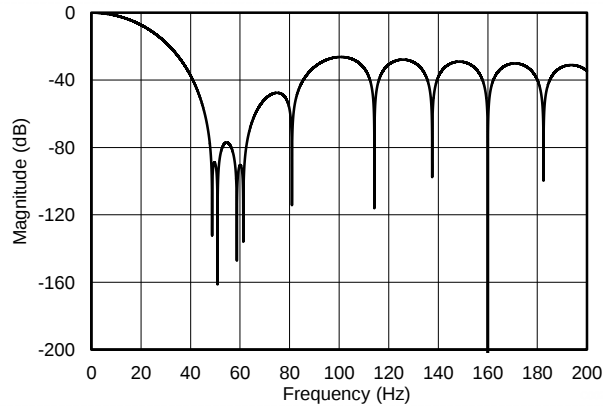
**Figure 45. Detailed View of Filter Response  
(Data Rate = 20 SPS, 50-Hz Rejection Only)**



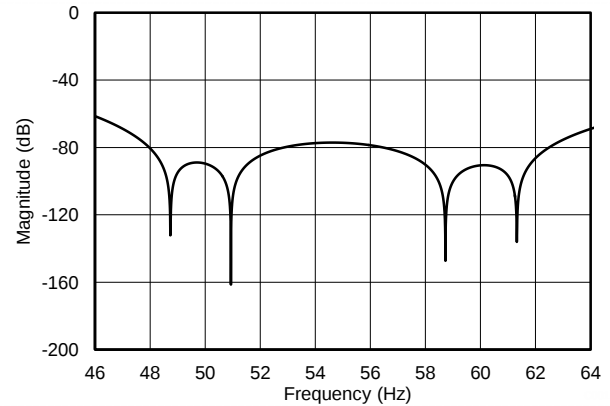
**Figure 46. Filter Response  
(Data Rate = 20 SPS, 60-Hz Rejection Only)**



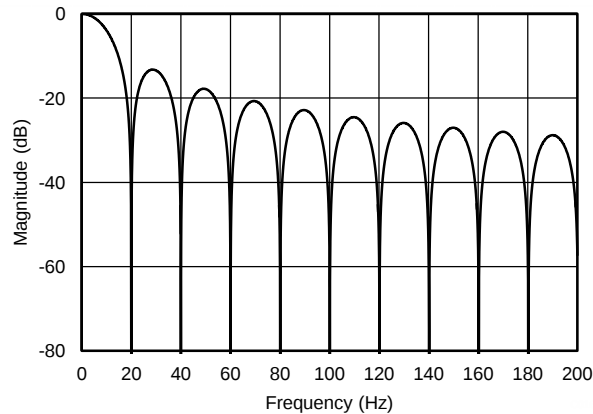
**Figure 47. Detailed View of Filter Response  
(Data Rate = 20 SPS, 60-Hz Rejection Only)**



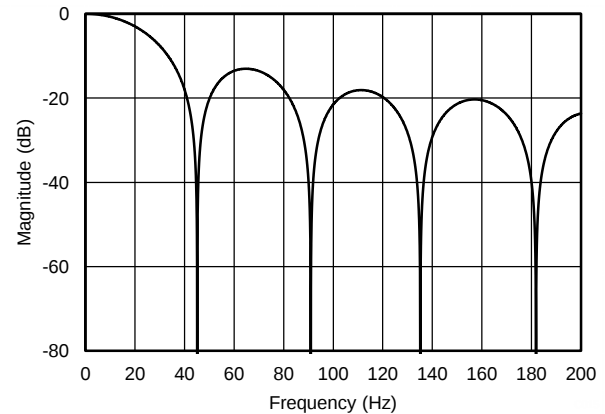
**Figure 48. Filter Response**  
(Data Rate = 20 SPS, Simultaneous 50- and 60-Hz Rejection)



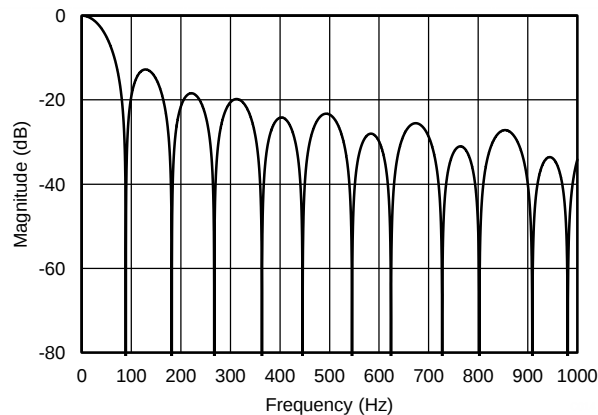
**Figure 49. Detailed View of Filter Response**  
(Data Rate = 20 SPS, Simultaneous 50- and 60-Hz Rejection)



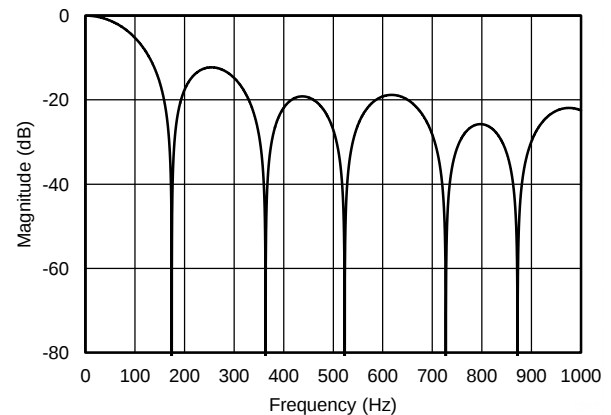
**Figure 50. Filter Response**  
(Data Rate = 20 SPS, No 50- or 60-Hz Rejection)



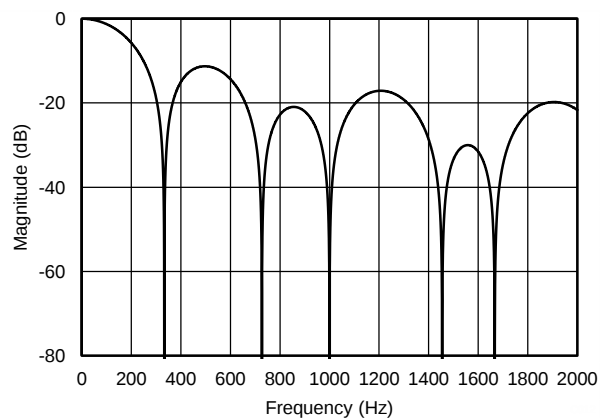
**Figure 51. Filter Response**  
(Data Rate = 45 SPS)



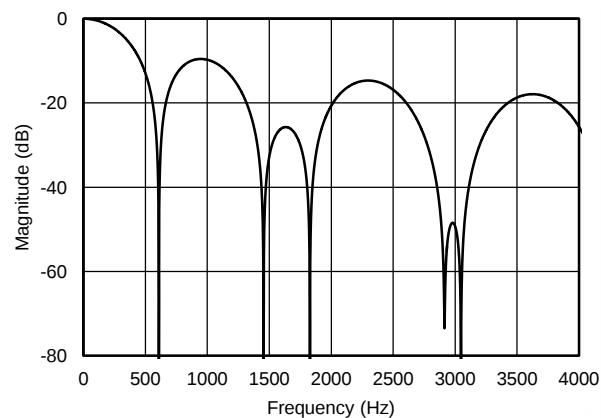
**Figure 52. Filter Response**  
(Data Rate = 90 SPS)



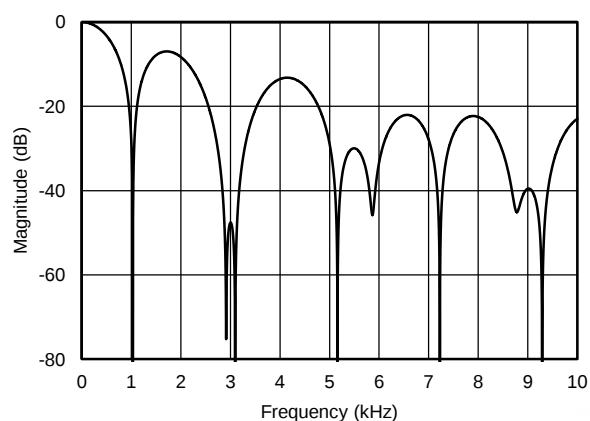
**Figure 53. Filter Response**  
(Data Rate = 175 SPS)



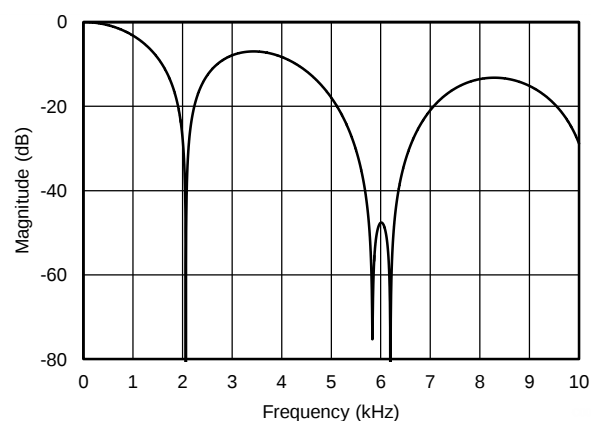
**Figure 54. Filter Response  
(Data Rate = 330 SPS)**



**Figure 55. Filter Response  
(Data Rate = 600 SPS)**



**Figure 56. Filter Response  
(Data Rate = 1 kSPS)**



**Figure 57. Filter Response  
(Data Rate = 2 kSPS)**

## OUTPUT DATA RATE

Table 7, Table 8, and Table 9 show the actual conversion times for each data rate setting. The values provided are in terms of  $t_{CLK}$  cycles using an external clock with a clock frequency of  $f_{CLK} = 4.096$  MHz.

Single-shot mode data rates are timed from the last SCLK falling edge of the START/SYNC command to the DRDY falling edge and rounded to the next  $t_{CLK}$ . In case the internal oscillator is used, an additional oscillator wake-up time of up to 50  $\mu$ s (normal mode, duty-cycle mode) or 25  $\mu$ s (turbo mode), respectively, for each conversion in single-shot mode must be added. The internal oscillator starts to power up at the first SCLK rising edge. Depending on the SCLK frequency, the oscillator cannot be ensured to be fully powered up at the end of the START/SYNC command. A conversion therefore only starts after the internal oscillator is fully powered up.

Continuous conversion data rates are timed from one  $\overline{DRDY}$  falling edge the next  $\overline{DRDY}$  falling edge. The first conversion starts  $210 \times t_{CLK}$  (normal mode, duty-cycle mode) or  $114 \times t_{CLK}$  (turbo mode), respectively, after the last SCLK falling edge of the START/SYNC command.

**Table 7. Normal Mode**

| NOMINAL DATA RATE<br>(SPS) | –3-dB BANDWIDTH<br>(Hz) | ACTUAL CONVERSION TIME ( $t_{CLK}$ ) |                            |
|----------------------------|-------------------------|--------------------------------------|----------------------------|
|                            |                         | SINGLE-SHOT MODE                     | CONTINUOUS CONVERSION MODE |
| 20                         | 13.1                    | 204850                               | 204768                     |
| 45                         | 20.0                    | 91218                                | 91120                      |
| 90                         | 39.6                    | 46226                                | 46128                      |
| 175                        | 77.8                    | 23762                                | 23664                      |
| 330                        | 150.1                   | 12562                                | 12464                      |
| 600                        | 279.0                   | 6994                                 | 6896                       |
| 1000                       | 483.8                   | 4242                                 | 4144                       |

**Table 8. Duty-Cycle Mode**

| NOMINAL DATA RATE<br>(SPS) | –3-dB BANDWIDTH<br>(Hz) | ACTUAL CONVERSION TIME ( $t_{CLK}$ ) |                            |
|----------------------------|-------------------------|--------------------------------------|----------------------------|
|                            |                         | SINGLE-SHOT MODE                     | CONTINUOUS CONVERSION MODE |
| 5                          | 13.1                    | 204850                               | 823120                     |
| 11.25                      | 20.0                    | 91218                                | 364560                     |
| 22.5                       | 39.6                    | 46226                                | 184592                     |
| 44                         | 77.8                    | 23762                                | 94736                      |
| 82.5                       | 150.1                   | 12562                                | 49936                      |
| 150                        | 279.0                   | 6994                                 | 27664                      |
| 250                        | 483.8                   | 4242                                 | 16656                      |

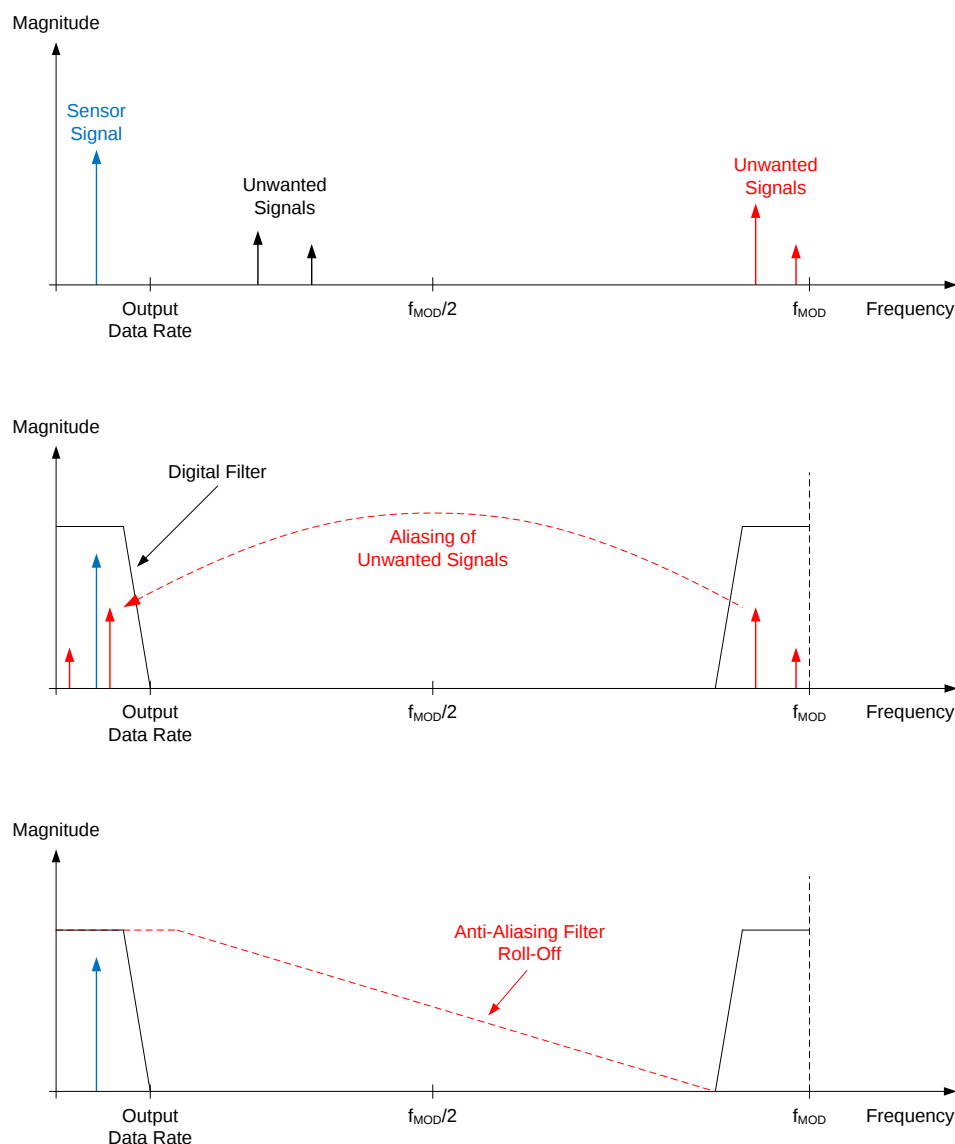
**Table 9. Turbo Mode**

| NOMINAL DATA RATE<br>(SPS) | –3-dB BANDWIDTH<br>(Hz) | ACTUAL CONVERSION TIME ( $t_{CLK}$ ) |                            |
|----------------------------|-------------------------|--------------------------------------|----------------------------|
|                            |                         | SINGLE-SHOT MODE                     | CONTINUOUS CONVERSION MODE |
| 40                         | 26.2                    | 102434                               | 102384                     |
| 90                         | 39.9                    | 45618                                | 45560                      |
| 180                        | 79.2                    | 23122                                | 23064                      |
| 350                        | 155.6                   | 11890                                | 11832                      |
| 660                        | 300.3                   | 6290                                 | 6232                       |
| 1200                       | 558.1                   | 3506                                 | 3448                       |
| 2000                       | 967.6                   | 2130                                 | 2072                       |

Note that even though the data rate at the 20-SPS setting is not exactly 20 SPS, this discrepancy does not effect the 50-Hz or 60-Hz rejection. To achieve the specified 50-Hz and 60-Hz rejection, the external clock frequency must only be ensured to be exactly 4.096 MHz.

## ALIASING

As with any sampled system, aliasing can occur if proper antialias filtering is not in place. Aliasing describes the effect that frequency components in the input signal that are higher than half the sampling frequency of the ADC (also known as the Nyquist frequency) are folded back and show up in the actual frequency band of interest below half the sampling frequency. Note that inside a  $\Delta\Sigma$  ADC, the input signal is sampled at the modulator frequency  $f_{\text{MOD}}$  and not at the output data rate. The filter response of the digital filter repeats at multiples of the sampling frequency ( $f_{\text{MOD}}$ ), as shown in Figure 58. Signals or noise up to a frequency where the filter response repeats are attenuated by the digital filter. However, any frequency components present in the input signal around the modulator frequency or multiples thereof are not attenuated and thus alias back into the band of interest, unless attenuated by an external analog filter. Some signals are inherently bandlimited; for example, the output of a thermocouple has a limited rate of change. Nevertheless, these signals can contain noise and interference components at higher frequencies, which can fold back into the frequency band of interest. A simple RC filter is (in most cases) sufficient to reject these high-frequency components. When designing an input filter circuit, be sure to take into account the interaction between the filter network and the input impedance of the ADS1220.



**Figure 58. Effect of Aliasing**

## VOLTAGE REFERENCE

The ADS1220 offers an integrated low-drift, 2.048-V reference. For applications that require a different reference voltage value or a ratiometric measurement approach, the device offers two differential reference inputs (REFP<sub>x</sub> and REFN<sub>x</sub>). In addition, the analog supply (AVDD) can be used as a reference. The differential reference inputs allow freedom in the reference common-mode voltage. REFP<sub>0</sub> and REFN<sub>0</sub> are dedicated reference inputs whereas REFP<sub>1</sub> and REFN<sub>1</sub> are shared with inputs AIN<sub>0</sub> and AIN<sub>3</sub>, respectively. The reference inputs are internally buffered to increase input impedance. Therefore, additional reference buffers are usually not required when using an external reference and the reference inputs do not load any external circuitry when used in ratiometric applications. The reference source is selected by two bits (VREF[1:0]) in the configuration register. By default, the internal reference is selected.

## CLOCK SOURCE

The device system clock can either be provided by the internal low-drift oscillator or by an external clock source on the CLK input. Connect the CLK pin to DGND before power-up or reset to activate the internal oscillator. Connecting an external clock to the CLK pin at any time deactivates the internal oscillator after two rising edges on the CLK pin are detected. The device then operates on the external clock. After the ADS1220 switches to the external clock, the device cannot be switched back to the internal oscillator without cycling the power supplies or sending a RESET command.

## EXCITATION CURRENT SOURCES

The ADS1220 provides two matched programmable excitation current sources (IDACs) for RTD applications. The output current of the current sources can be programmed to 10  $\mu$ A, 50  $\mu$ A, 100  $\mu$ A, 250  $\mu$ A, 500  $\mu$ A, 1000  $\mu$ A, or 1500  $\mu$ A using the respective bits (IDAC[2:0]) in the configuration register. Each current source can be connected to any of the analog inputs (AIN<sub>x</sub>) as well as to any of the dedicated reference inputs (REFP<sub>0</sub> and REFN<sub>0</sub>). Both current sources can also be connected to the same pin. Routing of the IDACs is configured by bits (I1MUX[2:0], I2MUX[2:0]) in the configuration register. Care should be taken not to exceed the compliance voltage of the IDACs. In other words, the voltage on the pin where the IDAC is routed to should be limited to  $\leq (AVDD - 0.9 \text{ V})$ , otherwise the specified accuracy of the IDAC current is not met. For three-wire RTD applications, the matched current sources can be used to cancel the errors caused by sensor lead resistance.

The IDACs require up to 200  $\mu$ s to start up after the IDAC current is programmed to the respective value using bits IDAC[2:0]. If configuration register 2 and 3 are not written during the same WREG command, TI recommends to first set the IDAC current to the respective value using bits IDAC[2:0] and thereafter select the routing for each IDAC (I1MUX[2:0], I2MUX[2:0]).

In single-shot mode, the IDACs remain active between any two conversions if the IDAC[2:0] bits are set to a value other than 000. However, the IDACs are powered down whenever the POWERDOWN command is issued.

## SENSOR DETECTION

To help detect a possible sensor malfunction, the device provides internal 10- $\mu$ A, burn-out current sources. When enabled by setting the respective bit (BCS) in the configuration register, one current source sources current to the positive analog input (AIN<sub>P</sub>) currently selected and the other current source sinks current from the selected negative analog input (AIN<sub>N</sub>).

In case of an open circuit in the sensor, these burn-out current sources pull the positive input towards AVDD and the negative input towards AVSS, resulting in a full-scale reading. A full-scale reading may also indicate that the sensor is overloaded or that the reference voltage is absent. A near-zero reading may indicate a shorted sensor. However, because the absolute value of the burn-out current sources typically varies by  $\pm 10\%$  and the internal multiplexer adds a small series resistance, distinguishing a shorted sensor condition from a normal reading can be difficult, especially if an RC filter is used at the inputs. In other words, even if the sensor fails short, the voltage drop across the external filter resistance and the residual resistance of the multiplexer causes the output to read a value higher than zero.

If a higher precision current source is required for sensor short detection, TI recommends using the excitation current sources (IDACs). Keep in mind that ADC readings of a functional sensor may be corrupted when the burn-out current sources are enabled.

## LOW-SIDE POWER SWITCH

A low-side power switch with low on-resistance connected between the analog input AIN3/REFN1 and AVSS is integrated in the ADS1220 as well. This power switch can be used to reduce system power consumption in bridge sensor applications by powering down the bridge circuit between conversions. When the respective bit (PSW) in the configuration register is set, the switch automatically closes during conversions and opens when the device is in power-down mode. By default, the switch is always open.

## SYSTEM MONITOR

The device provides some means for monitoring the AVDD analog power supply and the external voltage reference. To select any monitoring voltages, the internal multiplexer (MUX[3:0]) must be configured accordingly in the configuration register. Note that the system monitor function only provides a coarse result and is not meant to be a precision measurement.

When measuring the analog power supply (MUX[3:0] = 1101), the resulting conversion is approximately  $(AVDD - AVSS) / 4$ . The device uses the internal reference for the measurement regardless of what reference source is selected in the configuration register (VREF[1:0]).

When monitoring one of the two possible external reference voltage sources (MUX[3:0] = 1100), the result is approximately  $(REFPx - REFNx) / 4$ . REFPx and REFNx denote the external reference input pair selected in the configuration register (VREF[1:0]). The ADS1220 automatically uses the internal reference for the measurement.

## OFFSET CALIBRATION

The internal multiplexer offers the option to short both PGA inputs (AIN<sub>P</sub> and AIN<sub>N</sub>) to mid-supply  $(AVDD + AVSS) / 2$ . This option can be used to calibrate the device offset voltage by storing the result of the shorted input voltage reading in a microcontroller and consequently subtracting the result from each following reading. TI recommends taking multiple readings with the inputs shorted and averaging the result to reduce the effect of noise.

## POWER SUPPLIES

The device has two power supplies: analog (AVDD, AVSS) and digital (DVDD, DGND). The analog power supply can be bipolar (for example, AVDD = +2.5 V, AVSS = -2.5 V) or single supply (for example, AVDD = +3.3 V, AVSS = 0 V) and is independent of the digital power supply. The digital supply range sets the digital I/O levels. The power supplies can be sequenced in any order but in no case should any of the analog or digital inputs exceed the respective analog or digital power-supply voltage limits.

## TEMPERATURE SENSOR

The temperature measurement mode of the device is configured as a 14-bit result when enabled by the TS bit in the configuration register. Data are output starting with the most significant byte (MSB). When reading the three data bytes, the first 14 bits are used to indicate the temperature measurement result. The last 10 bits are random data and must be ignored. That is, the 14-bit temperature result is left-justified within the 24-bit conversion result. One 14-bit LSB equals 0.03125°C. Negative numbers are represented in binary twos complement format.

**Table 10. 14-Bit Temperature Data Format**

| TEMPERATURE (°C) | DIGITAL OUTPUT (BINARY) | HEX  |
|------------------|-------------------------|------|
| 128              | 01 0000 0000 0000       | 1000 |
| 127.96875        | 00 1111 1111 1111       | 0FFF |
| 100              | 00 1100 1000 0000       | 0C80 |
| 80               | 00 1010 0000 0000       | 0A00 |
| 75               | 00 1001 0110 0000       | 0960 |
| 50               | 00 0110 0100 0000       | 0640 |
| 25               | 00 0011 0010 0000       | 0320 |
| 0.25             | 00 0000 0000 1000       | 0008 |
| 0                | 00 0000 0000 0000       | 0000 |
| –0.25            | 11 1111 1111 1000       | 3FF8 |
| –25              | 11 1100 1110 0000       | 3CE0 |
| –55              | 11 1001 0010 0000       | 3920 |

### Converting from Temperature to Digital Codes

#### *For Positive Temperatures (for example, +50°C):*

Twos complement is not performed on positive numbers. Therefore, simply convert the number to binary code in a 14-bit, left-justified format with the MSB = 0 to denote the positive sign.

Example:  $(+50^{\circ}\text{C}) / (0.03125^{\circ}\text{C per count}) = 1600 = 0640\text{h} = 00\ 0110\ 0100\ 0000$

#### *For Negative Temperatures (for example, –25°C):*

Generate the twos complement of a negative number by complementing the absolute binary number and adding '1'. Then, denote the negative sign with the MSB = 1.

Example:  $(|-25^{\circ}\text{C}|) / (0.03125^{\circ}\text{C per count}) = 800 = 0320\text{h} = 00\ 0011\ 0010\ 0000$

Twos complement format:  $11\ 1100\ 1101\ 1111 + 1 = 11\ 1100\ 1110\ 0000$

### Converting from Digital Codes to Temperature

To convert from digital codes to temperature, first check whether the MSB is a '0' or a '1'. If the MSB is a '0', simply multiply the decimal code by 0.03125°C to obtain the result. If the MSB = 1, subtract '1' from the result and complement all bits. Then, multiply the result by –0.03125°C.

Example: The ADS1220 reads back 0960h: 0960h has an MSB = 0.

$(0960\text{h}) \times (0.03125^{\circ}\text{C}) = (2400) \times (0.03125^{\circ}\text{C}) = +75^{\circ}\text{C}$

Example: The ADS1220 reads back 3CE0h: 3CE0h has an MSB = 1.

Complement the result:  $3CE0\text{h} \rightarrow 0320\text{h} \ (0320\text{h}) \times (-0.03125^{\circ}\text{C}) = (800) \times (-0.03125^{\circ}\text{C}) = -25^{\circ}\text{C}$

## RESET AND POWER-UP

When the device powers up, a reset is performed. As part of the reset process, the device sets all bits in the configuration registers to the respective default settings. By default, the device is set to single-shot mode. After power-up, the device performs a single conversion using the default register settings and then enters a low-power state. The power-up behavior is intended to prevent systems with tight power-supply requirements from encountering a current surge during power-up.

## CONVERSION MODES

The device can be operated in one of two conversion modes that can be selected by the CM bit in the configuration register. These conversion modes are single-shot or continuous conversion mode.

### Single-Shot Mode

In single-shot mode, the device only performs a conversion when a START/SYNC command is issued. The device consequently performs one single conversion and returns to a low-power state afterwards. The internal oscillator and all analog circuitry (except for the excitation current sources) are turned off while the device waits in this low-power state until the next conversion is started. In addition, every write access to any configuration register also starts a new conversion. Writing to any configuration register while a conversion is ongoing functions as a new START/SYNC command that stops the current conversion and restarts a single new conversion. Because the ADS1220 digital filter settles within a single cycle, each conversion is fully settled assuming the analog input signal is settled to its final value before the conversion starts.

### Continuous Conversion Mode

In continuous conversion mode, the device continuously performs conversions. When a conversion completes, the device places the result in the output buffer and immediately begins another conversion.

In order to start continuous conversion mode, the CM bit must be set to '1' followed by a START/SYNC command. The first conversion starts  $210 \times t_{CLK}$  (normal mode, duty-cycle mode) or  $114 \times t_{CLK}$  (turbo mode), respectively, after the last SCLK falling edge of the START/SYNC command. Writing to any configuration register while the START/SYNC command is not issued starts a single conversion, whereas a write access to the configuration register during an ongoing conversion restarts the current conversion. TI recommends to always send a START/SYNC command immediately after the CM bit is set to '1'.

## OPERATING MODES

In addition to the different conversion modes, the ADS1220 can also be operated in different operating modes that can be selected to trade off power consumption, noise performance, and output data rate.

### Normal Mode

Normal mode is the default mode the device operates in. In this mode, the internal modulator of the  $\Delta\Sigma$  ADC runs at a modulator clock frequency of  $f_{MOD} = f_{CLK} / 16$ , where the system clock ( $f_{CLK}$ ) is either provided by the internal oscillator or the external clock source. The modulator frequency using the internal oscillator is 256 kHz. Normal mode offers output data rate options ranging from 20 SPS to 1 kSPS with the internal oscillator. The data rate is selected by bits (DR[2:0]) in the configuration register. In case an external clock source with a clock frequency other than 4.096 MHz is used, the data rates scale accordingly. For example, using an external clock with  $f_{CLK} = 2.048$  MHz yields data rates ranging from 10 SPS to 500 SPS.

### Duty-Cycle Mode

The noise performance of a  $\Delta\Sigma$  ADC generally improves when lowering the output data rate because more samples of the internal modulator can be averaged to yield one conversion result. In applications where power consumption is critical, the improved noise performance at low data rates may not be required. For these applications, the device supports an internal duty cycling that can yield significant power savings by periodically entering a low-power state between conversions. In principle, the device runs in normal mode with a duty cycle of 25%. This functionality means the device performs one conversion in the same manner as when running in normal mode but then automatically enters a low power-state for three consecutive conversion cycles. The noise performance in duty-cycle mode is therefore comparable to the noise performance in normal mode at four times the data rate. Data rates in duty-cycle mode range from 5 SPS to 250 SPS with the internal oscillator.

## Turbo Mode

Applications that require higher data rates up to 2 kSPS can operate the device in turbo mode. In this mode, the internal modulator runs at a higher frequency of  $f_{MOD} = f_{CLK} / 8$ .  $f_{MOD} = 512$  kHz when the internal oscillator or an external 4.096-MHz clock is used. Note that the device power consumption does increase because the modulator runs at a higher frequency.

## Power-Down Mode

When the POWERDOWN command is issued, the device enters power-down mode after completing the current conversion. In this mode, all analog circuitry is powered down and the device typically only uses 400 nA of current. During this time, the device holds the configuration register settings and responds to commands, but does not perform any data conversion.

Issuing a START/SYNC command wakes up the device and either starts a single conversion or starts continuous conversion mode depending on the conversion mode selected by the CM bit. Writing to any configuration register bit wakes up the device as well, but only starts a single conversion regardless of what conversion mode (CM) the device is set to. TI recommends to always send a START/SYNC command immediately after writing to any of the configuration registers.

## SERIAL INTERFACE

The SPI-compatible serial interface of the device is used to read conversion data, read and write the device configuration registers, and control device operation. The interface consists of five control lines ( $\overline{CS}$ , SCLK, DIN, DOUT/ $\overline{DRDY}$ , and  $\overline{DRDY}$ ) but can be used with four or even three control signals (SCLK, DIN, and DOUT/ $\overline{DRDY}$ ) as well. In the latter case,  $\overline{CS}$  may be tied low if the serial bus is not shared with any other device. The dedicated data-ready signal ( $\overline{DRDY}$ ) can be configured to be shared with DOUT/ $\overline{DRDY}$ .

## CHIP SELECT ( $\overline{CS}$ )

Chip select ( $\overline{CS}$ ) is an active-low input that selects the device for SPI communication. This feature is useful when multiple devices share the same serial bus.  $\overline{CS}$  must remain low for the duration of the serial communication. When  $\overline{CS}$  is taken high, the serial interface is reset, SCLK is ignored, and DOUT/ $\overline{DRDY}$  enters a high-impedance state; as such, DOUT/ $\overline{DRDY}$  cannot indicate when data are ready. In situations where multiple devices are present on the bus, the dedicated  $\overline{DRDY}$  pin can provide an uninterrupted monitor of the result status. New data can be transferred at anytime without concern of data corruption. When a transmission starts, the current result is loaded into the output shift register and does not change until the communication is complete. This implementation avoids any possibility of data corruption. If the serial bus is not shared with another peripheral,  $\overline{CS}$  may be tied low.

## SERIAL CLOCK (SCLK)

The serial clock (SCLK) features a Schmitt-triggered input and is used to clock data into and out of the device on the DIN and DOUT/ $\overline{DRDY}$  pins, respectively. Even though the input has hysteresis, TI recommends keeping SCLK as clean as possible to prevent glitches from accidentally shifting the data. If a complete command is not sent within  $13955 \times t_{MOD}$  (normal mode, duty-cycle mode) or  $27910 \times t_{MOD}$  (turbo mode), respectively, the serial interface resets and the next SCLK pulse starts a new communication cycle. This timeout feature can be used to recover communication when a serial interface transmission is interrupted. When the serial interface is idle, hold SCLK low.

## DATA READY ( $\overline{DRDY}$ )

$\overline{DRDY}$  indicates when a new conversion result is ready for retrieval. When  $\overline{DRDY}$  falls low, new conversion data are ready.  $\overline{DRDY}$  always transitions high on the next SCLK rising edge. When no data are read during continuous conversion mode,  $\overline{DRDY}$  remains low but pulses high  $2 \times t_{MOD}$  before the next  $\overline{DRDY}$  falling edge. The  $\overline{DRDY}$  pin is always actively driven even when  $\overline{CS}$  is high.

## DATA INPUT (DIN)

The data input pin (DIN) is used along with SCLK to send data (commands and register data) to the device. The device latches data on DIN on the SCLK falling edge. The device never drives the DIN pin.

## DATA OUTPUT AND DATA READY (DOUT/ $\overline{\text{DRDY}}$ )

DOUT/ $\overline{\text{DRDY}}$  has a dual output function. This pin is used with SCLK to read conversion and register data from the device but can, in addition, be configured as a data-ready indicator. Data on DOUT/ $\overline{\text{DRDY}}$  are shifted out on the SCLK rising edge. DOUT/ $\overline{\text{DRDY}}$  goes to a high-impedance state when  $\overline{\text{CS}}$  is high.

Setting the  $\overline{\text{DRDYM}}$  bit in the configuration register high also configures DOUT/ $\overline{\text{DRDY}}$  as a data-ready indicator. DOUT/ $\overline{\text{DRDY}}$  then transitions low at the same time the  $\overline{\text{DRDY}}$  pin goes low to indicate new conversion data are available. Both signals can be used to detect if new data are ready. However, because DOUT/ $\overline{\text{DRDY}}$  is disabled when  $\overline{\text{CS}}$  is high, only the dedicated  $\overline{\text{DRDY}}$  pin can be used in case multiple devices on the bus must be monitored for end of conversion.

## DATA FORMAT

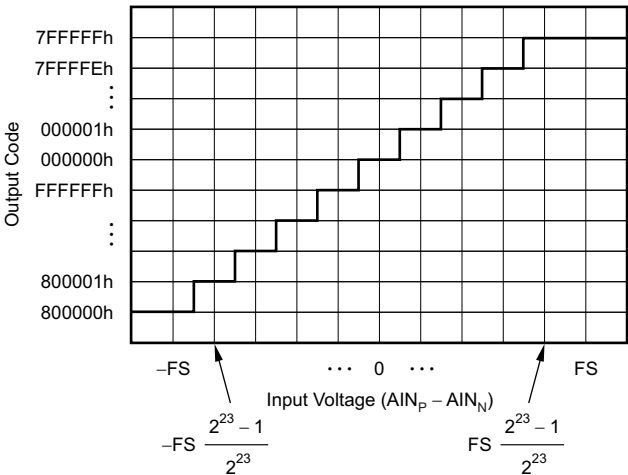
The device provides 24 bits of data in binary twos complement format. The positive full-scale input produces an output code of 7FFFFFFh and the negative full-scale input produces an output code of 800000h. The output clips at these codes for signals that exceed full-scale (FS). Table 11 summarizes the ideal output codes for different input signals.

**Table 11. Ideal Output Code versus Input Signal**

| INPUT SIGNAL, $V_{\text{IN}}$<br>( $\text{AIN}_P - \text{AIN}_N$ ) | IDEAL OUTPUT CODE <sup>(1)</sup> |
|--------------------------------------------------------------------|----------------------------------|
| $\geq +\text{FS} (2^{23} - 1) / 2^{23}$                            | 7FFFFFFh                         |
| $+\text{FS} / 2^{23}$                                              | 000001h                          |
| 0                                                                  | 0                                |
| $-\text{FS} / 2^{23}$                                              | FFFFFFh                          |
| $\leq -\text{FS}$                                                  | 800000h                          |

(1) Excludes the effects of noise, INL, offset, and gain errors.

Mapping of the analog input signal to the output codes is illustrated in Figure 59.



**Figure 59. Code Transition Diagram**

## COMMANDS

The device offers six different commands to control device operation. Four commands are stand-alone instructions (RESET, START/SYNC, POWERDOWN, and RDATA). The commands to read (RREG) and write (WREG) configuration register data from and to the device require additional information as part of the instruction.

Operands:

- rr = Configuration register (00 to 11)
- nn = Number of bytes – 1 (00 to 11)
- x = Don't care

### WREG (0100 rrnn)

Writes the number of bytes specified by *nn* (number of bytes to be written – 1) to the device configuration register, starting at register address *rr*. The command is completed after *nn* + 1 bytes are clocked in after the WREG command byte. The configuration registers are updated on the last SCLK falling edge. For example, the command to write two bytes (*nn* = 01) starting at configuration register 0 (*rr* = 00) is 0100 0001.

### RREG (0010 rrnn)

Reads the number of bytes specified by *nn* (number of bytes to be read – 1) from the device configuration register, starting at register address *rr*. The command is completed after *nn* + 1 bytes are clocked out after the RREG command byte. For example, the command to read three bytes (*nn* = 10) starting at configuration register 1 (*rr* = 01) is 0010 0110.

### RESET (0000 011x)

Resets the device to the default values.

### START/SYNC (0000 100x)

In single-shot mode, the START/SYNC command is used to start a single conversion or when sent during an ongoing conversion, to reset the digital filter, and to restart a single new conversion. When the device is set to continuous conversion mode, the START/SYNC command must be issued to start converting. Sending the START/SYNC command while converting in continuous conversion mode resets the digital filter and starts converting from there.

### POWERDOWN (0000 001x)

Places the device into power-down mode. This command shuts down all internal analog components, opens the low-side switch, turns off both IDACs, but holds all register values. As soon as a START/SYNC command is issued, all analog components return to their previous states.

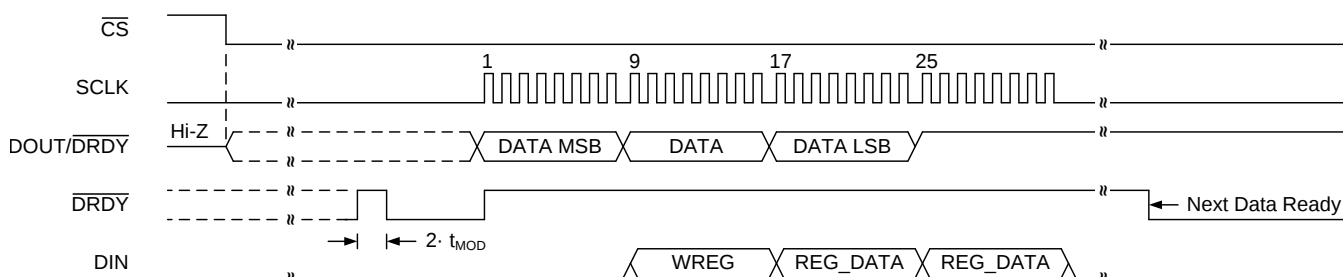
### RDATA (0001 xxxx)

Loads the output shift register with the most recent conversion result. This command can be used when DOUT/DRDY or DRDY are not monitored to indicate that a new conversion result is available. If a conversion finishes in the middle of the RDATA command byte, the more reliable result (either the old result or the new one) is loaded into the output shift register. The state of the DRDY pin signals whether the old or the new result is loaded. If the old result is loaded, DRDY stays low, indicating that the new result has not been read out. The new conversion result loads when DRDY is high.

## SENDING COMMANDS

The device serial interface is capable of full-duplex operation, which means commands are decoded at the same time that conversion data are read. Commands may be sent on any 8-bit data boundary during a data read operation. When a RREG or RDATA command is recognized, the current data read operation is overridden and the data is corrupted, unless the command is sent together with the last byte of the data read operation. The device starts to output the requested data on DOUT/DRDY at the first SCLK rising edge after the command byte. To read data without interruption, keep DIN low.

A WREG command can be sent without corrupting an ongoing read operation. [Figure 60](#) shows an example for sending a WREG command to write two configuration registers while reading conversion data in continuous conversion mode. Note that after the command is clocked in (after the 32nd SCLK falling edge), the device resets the digital filter and starts converting using the new register settings. The WREG command can be sent on any of the 8-bit boundaries. That means on the first, ninth, 17th or 25th SCLK rising edge in [Figure 60](#).

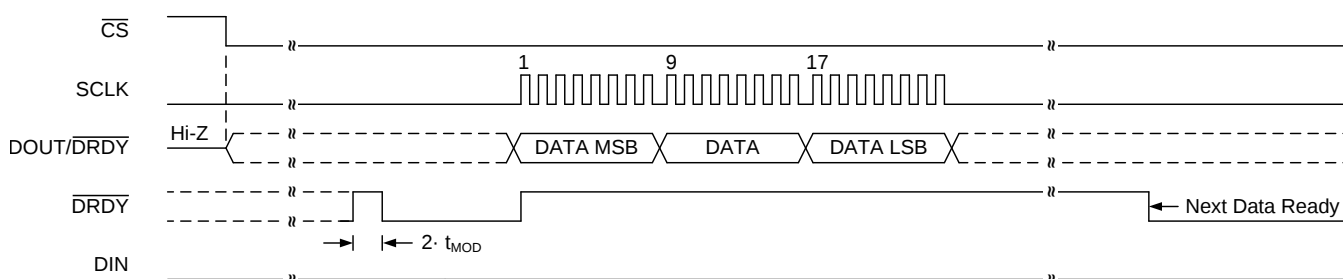


**Figure 60. Example of a WREG Command**

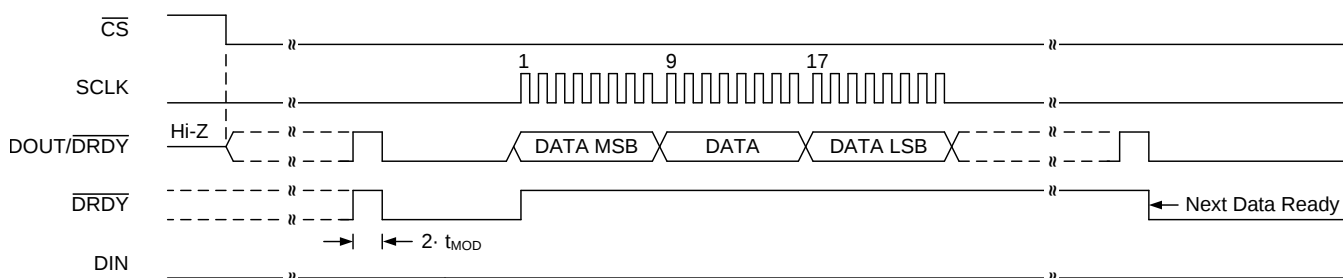
## READING DATA

Output pins  $\overline{\text{DRDY}}$  and DOUT/ $\overline{\text{DRDY}}$  (if configured in the respective DRDYM configuration register bit) transition low when new data are ready for retrieval. The conversion data are written to an internal data buffer. Data can be read directly from this buffer on DOUT/DRDY when DRDY falls low. A command does not have to be sent. Data are shifted out on the SCLK rising edges, MSB first, and consist of three bytes of data.

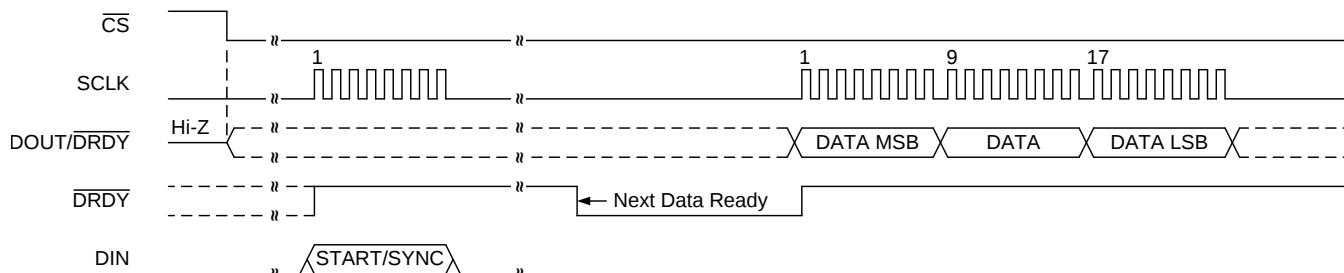
[Figure 61](#) to [Figure 63](#) show the timing diagrams for continuous conversion mode and single-shot mode.



**Figure 61. Continuous Conversion Mode (DRDYM = 0)**

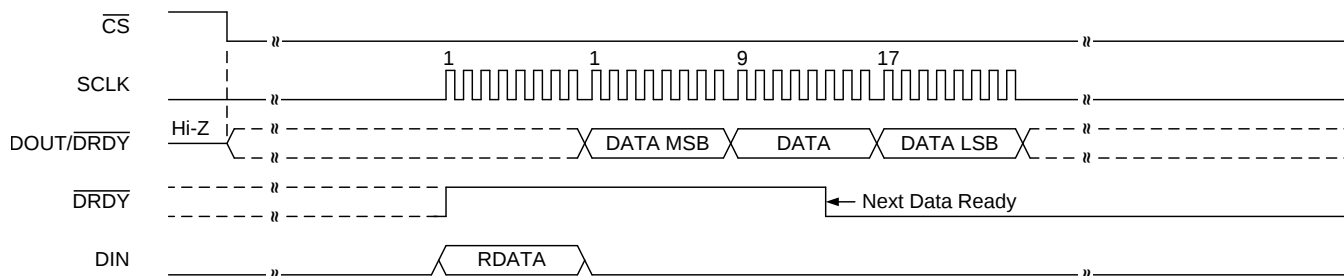


**Figure 62. Continuous Conversion Mode (DRDYM = 1)**

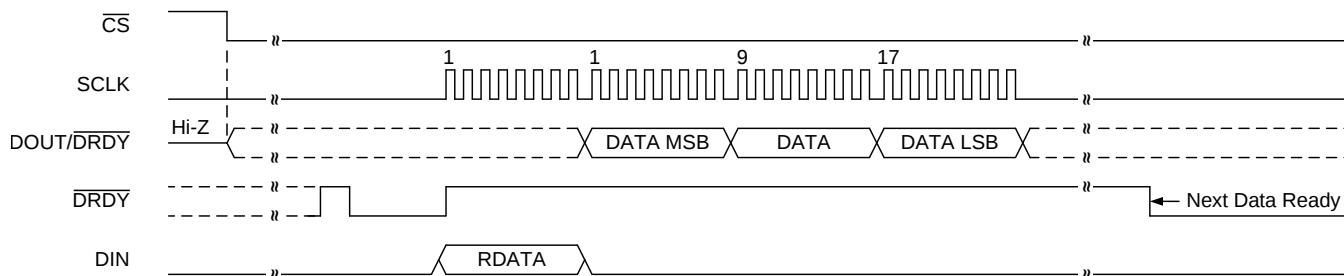


**Figure 63. Single-Shot Mode (DRDYM = 0)**

Data can also be read at any time without necessarily synchronizing to the  $\overline{DRDY}$  signal using the RDATA command. When an RDATA command is issued, the conversion result currently stored in the data buffer can be shifted out on  $DOUT/\overline{DRDY}$  on the following  $SCLK$  rising edge. Data can be read continuously with the RDATA command as an alternative to monitoring  $\overline{DRDY}$  or  $DOUT/\overline{DRDY}$ . The  $\overline{DRDY}$  pin must then be polled after the LSB is clocked out to determine if a new conversion result is loaded. If a new conversion completes during the read operation but data from the previous conversion is read, then  $\overline{DRDY}$  is low. Otherwise, if the most recent result is read,  $\overline{DRDY}$  is high. Figure 64 and Figure 65 illustrate the behavior for both cases.



**Figure 64. State of  $\overline{DRDY}$  when a New Conversion Finishes During an RDATA Command**



**Figure 65. State of  $\overline{DRDY}$  when the Most Recent Conversion Result is Read During an RDATA Command**

## CONFIGURATION REGISTERS

The device has four 8-bit configuration registers that are accessible via the SPI port. The configuration registers control how the device operates and can be changed at any time without causing data corruption. After power-up and reset, all registers are set to the default values (which are all '0'). [Table 12](#) shows the register map of the configuration register.

**Table 12. Configuration Register Map (Read/Write)**

| REGISTER (Hex) | BIT 7      | BIT 6 | BIT 5       | BIT 4      | BIT 3     | BIT 2     | BIT 1 | BIT 0      |
|----------------|------------|-------|-------------|------------|-----------|-----------|-------|------------|
| 00h            | MUX[3:0]   |       |             |            | GAIN[2:0] |           |       | PGA_BYPASS |
| 01h            | DR[2:0]    |       |             | MODE[1:0]  |           | CM        | TS    | BCS        |
| 02h            | VREF[1:0]  |       | 50/60 [1:0] |            | PSW       | IDAC[2:0] |       |            |
| 03h            | I1MUX[2:0] |       |             | I2MUX[2:0] |           |           | DRDYM | RESERVED   |

### 00h Configuration Register 0

#### Bits [7:4] MUX[3:0]: Input multiplexer configuration

These bits configure the input multiplexer. No effect when in temperature sensor mode.

For settings where  $A\text{IN}_N = \text{AVSS}$ , the PGA must be disabled ( $\text{PGA\_BYPASS} = 1$ ) and only gains 1, 2, and 4 can be used.

|                                                                                |                                                                                       |
|--------------------------------------------------------------------------------|---------------------------------------------------------------------------------------|
| 0000 : $A\text{IN}_P = A\text{IN}_0$ , $A\text{IN}_N = A\text{IN}_1$ (default) | 1000 : $A\text{IN}_P = A\text{IN}_0$ , $A\text{IN}_N = \text{AVSS}$                   |
| 0001 : $A\text{IN}_P = A\text{IN}_0$ , $A\text{IN}_N = A\text{IN}_2$           | 1001 : $A\text{IN}_P = A\text{IN}_1$ , $A\text{IN}_N = \text{AVSS}$                   |
| 0010 : $A\text{IN}_P = A\text{IN}_0$ , $A\text{IN}_N = A\text{IN}_3$           | 1010 : $A\text{IN}_P = A\text{IN}_2$ , $A\text{IN}_N = \text{AVSS}$                   |
| 0011 : $A\text{IN}_P = A\text{IN}_1$ , $A\text{IN}_N = A\text{IN}_2$           | 1011 : $A\text{IN}_P = A\text{IN}_3$ , $A\text{IN}_N = \text{AVSS}$                   |
| 0100 : $A\text{IN}_P = A\text{IN}_1$ , $A\text{IN}_N = A\text{IN}_3$           | 1100 : $(\text{REFP}_x - \text{REFN}_x) / 4$ monitor (PGA bypassed)                   |
| 0101 : $A\text{IN}_P = A\text{IN}_2$ , $A\text{IN}_N = A\text{IN}_3$           | 1101 : $(\text{AVDD} - \text{AVSS}) / 4$ monitor (PGA bypassed)                       |
| 0110 : $A\text{IN}_P = A\text{IN}_1$ , $A\text{IN}_N = A\text{IN}_0$           | 1110 : $A\text{IN}_P$ and $A\text{IN}_N$ shorted to $(\text{AVDD} + \text{AVSS}) / 2$ |
| 0111 : $A\text{IN}_P = A\text{IN}_3$ , $A\text{IN}_N = A\text{IN}_2$           | 1111 : Not used                                                                       |

#### Bits [3:1] GAIN[2:0]: Gain configuration

These bits configure the device gain.

Gains 1, 2, and 4 can be used without the PGA. In this case, gain is obtained by a switched-capacitor structure. The gain setting has no effect when in temperature sensor mode.

|                          |
|--------------------------|
| 000 : Gain = 1 (default) |
| 001 : Gain = 2           |
| 010 : Gain = 4           |
| 011 : Gain = 8           |
| 100 : Gain = 16          |
| 101 : Gain = 32          |
| 110 : Gain = 64          |
| 111 : Gain = 128         |

#### Bit 0 PGA\_BYPASS: Disables internal low-noise PGA

Disabling the PGA reduces overall power consumption and allows the common-mode voltage range ( $V_{\text{CM}}$ ) to include AVSS and AVDD.

The PGA can only be disabled for gains 1, 2, and 4.

The PGA is always enabled for gain settings 8...128, regardless of the PGA\_BYPASS setting.

|                               |
|-------------------------------|
| 0 : PGA enabled (default)     |
| 1 : PGA disabled and bypassed |

**01h Configuration Register 1**
**Bits [7:5] DR[2:0]: Data rate**

These bits control the data rate setting depending on the selected operating mode.

**Normal mode**

000 : 20 SPS (default)  
001 : 45 SPS  
010 : 90 SPS  
011 : 175 SPS  
100 : 330 SPS  
101 : 600 SPS  
110 : 1000 SPS  
111 : Not used

**Duty-cycle mode**

000 : 5 SPS  
001 : 11.25 SPS  
010 : 22.5 SPS  
011 : 44 SPS  
100 : 82.5 SPS  
101 : 150 SPS  
110 : 250 SPS  
111 : Not used

**Turbo mode**

000 : 40 SPS  
001 : 90 SPS  
010 : 180 SPS  
011 : 350 SPS  
100 : 660 SPS  
101 : 1200 SPS  
110 : 2000 SPS  
111 : Not used

**Bits [4:3] MODE[1:0]: Operating mode**

This bit controls the operating mode the device operates in.

00 : Normal mode (256-kHz modulator clock) (default)  
01 : Duty-cycle mode (internal duty cycle of 1:4)  
10 : Turbo mode (512-kHz modulator clock)  
11 : Not used

**Bit 2 CM: Conversion mode**

This bit sets the conversion mode for the device.

0 : Single-shot mode (default)  
1 : Continuous conversion mode

**Bit 1 TS: Temperature sensor mode**

This bit enables the internal temperature sensor and puts the device in temperature sensor mode.

0 : Disables temperature sensor (default)  
1 : Enables temperature sensor

**Bit 0 BCS: Burn-out current sources**

This bit controls the 10-μA, burn-out current sources to detect wire breaks and shorts in the sensor.

0 : Current sources off (default)  
1 : Current sources on

|                   |                                                                                                                                                                                                                                                                                                                                                                                    |
|-------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>02h</b>        | <b>Configuration Register 2</b>                                                                                                                                                                                                                                                                                                                                                    |
| <b>Bits [7:6]</b> | <b>VREF[1:0]: Voltage reference selection</b><br>These bits select the voltage reference that is used for the conversion.<br>00 : Internal 2.048-V reference selected (default)<br>01 : External reference selected using dedicated REFPO and REFNO inputs<br>10 : External reference selected using AIN0/REFP1 and AIN3/REFN1 inputs<br>11 : Analog supply AVDD used as reference |
| <b>Bits [5:4]</b> | <b>50/60[1:0]: FIR filter configuration</b><br>Configures the filter coefficients for the internal FIR filter.<br>Only affects 20-SPS setting in normal mode and 5-SPS setting in duty-cycle mode.<br>00 : No 50-Hz or 60-Hz rejection (default)<br>01 : Simultaneous 50-Hz and 60-Hz rejection<br>10 : 50-Hz rejection only<br>11 : 60-Hz rejection only                          |
| <b>Bit [3]</b>    | <b>PSW: Low-side power switch configuration</b><br>When enabled, the low-side switch connected to AIN3/REFN1 automatically opens when the device is in power-down mode. When the device is converting, the switch closes.<br>0 : Switch is always open (default)<br>1 : Switch closes during conversions                                                                           |
| <b>Bits [2:0]</b> | <b>IDAC[2:0]: IDAC current setting</b><br>These bits set the current for both IDAC1 and IDAC2 excitation current sources.<br>000 : Off (default)<br>001 : 10 $\mu$ A<br>010 : 50 $\mu$ A<br>011 : 100 $\mu$ A<br>100 : 250 $\mu$ A<br>101 : 500 $\mu$ A<br>110 : 1000 $\mu$ A<br>111 : 1500 $\mu$ A                                                                                |

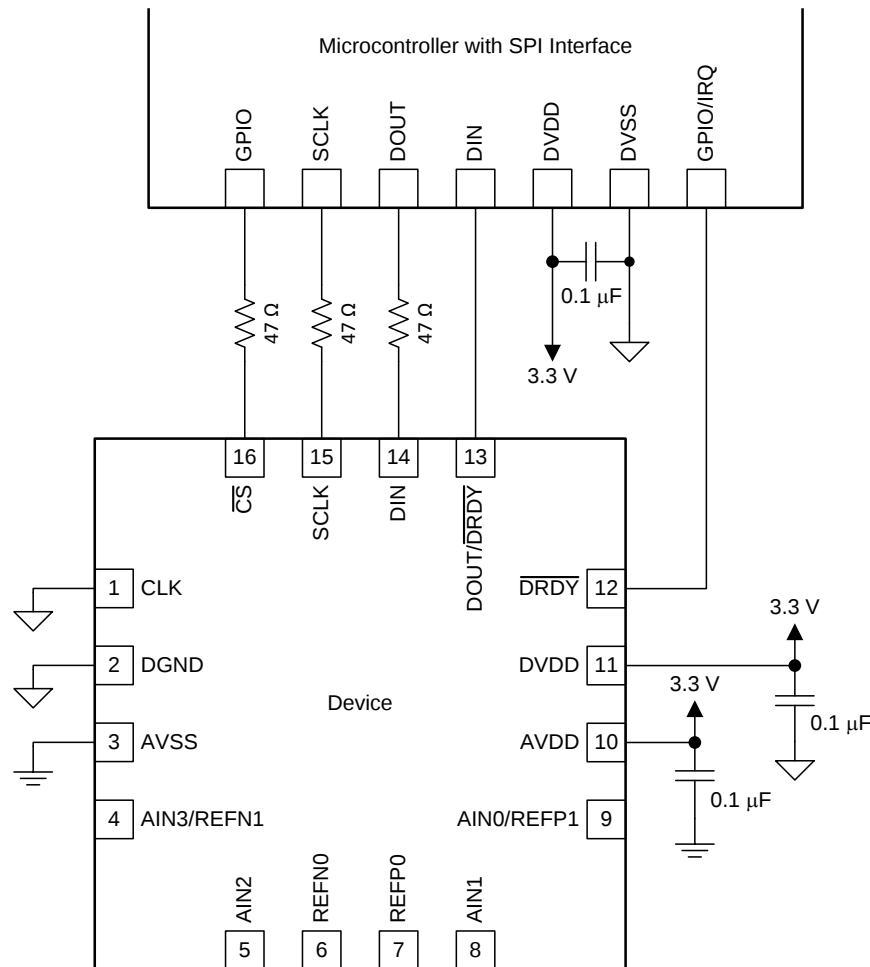
|                   |                                                                                                                                                                                                                                                                                                                                                                          |
|-------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>03h</b>        | <b>Configuration Register 3</b>                                                                                                                                                                                                                                                                                                                                          |
| <b>Bits [7:5]</b> | <b>I1MUX[2:0]: IDAC1 routing configuration</b><br>Selects the channel where IDAC1 is routed to.<br>000 : IDAC1 disabled (default)<br>001 : IDAC1 connected to AIN0/REFP1<br>010 : IDAC1 connected to AIN1<br>011 : IDAC1 connected to AIN2<br>100 : IDAC1 connected to AIN3/REFN1<br>101 : IDAC1 connected to REFPO<br>110 : IDAC1 connected to REFNO<br>111 : Not used  |
| <b>Bits [4:2]</b> | <b>I2MUX[2:0]: IDAC2 routing configuration</b><br>Selects the channel where IDAC2 is routed to.<br>000 : IDAC2 disabled (default)<br>001 : IDAC2 connected to AIN0/REFP1<br>010 : IDAC2 connected to AIN1<br>011 : IDAC2 connected to AIN2<br>100 : IDAC2 connected to AIN3/REFN1<br>101 : IDAC2 connected to REFPO<br>110 : IDAC2 connected to REFNO<br>111 : Not used  |
| <b>Bit 1</b>      | <b>DRDYM: <math>\overline{\text{DRDY}}</math> mode</b><br>Controls the behavior of the DOUT/ $\overline{\text{DRDY}}$ pin when new data are ready.<br>0 : Only the dedicated $\overline{\text{DRDY}}$ pin is used to indicate when data are ready (default)<br>1 : Data ready is indicated simultaneously on DOUT/ $\overline{\text{DRDY}}$ and $\overline{\text{DRDY}}$ |
| <b>Bit 0</b>      | <b>Reserved</b><br>Always write '0'                                                                                                                                                                                                                                                                                                                                      |

## APPLICATION INFORMATION

The following sections give example circuits and suggestions for using the ADS1220 in various situations.

### BASIC CONNECTIONS AND LAYOUT CONSIDERATIONS

For many applications, connecting the ADS1220 is simple. Figure 66 shows the principle power-supply and interface connections for the ADS1220.

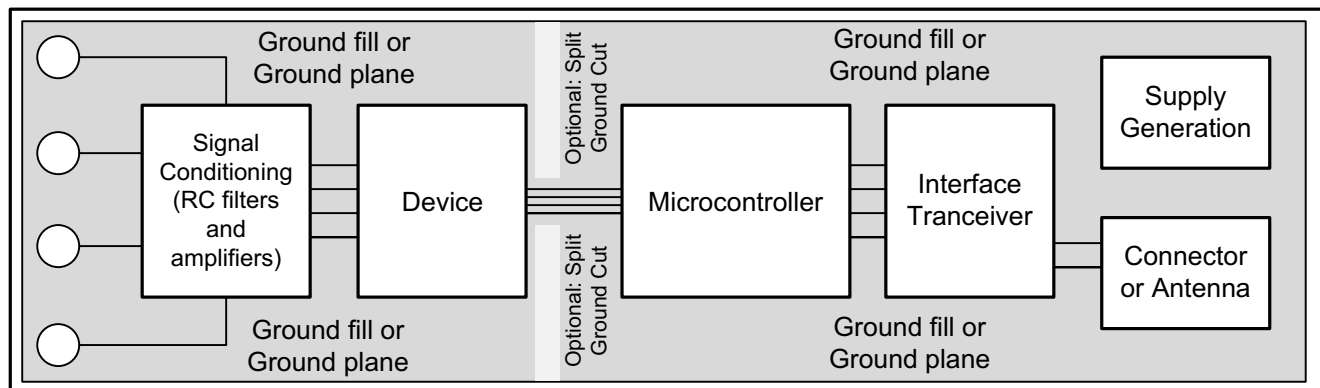


**Figure 66. Power-Supply and Interface Connections**

Most microcontroller SPI peripherals can operate with the ADS1220. The interface operates in SPI mode 1 where CPOL = 0 and CPHA = 1. In SPI mode 1, SCLK idles low and data are launched or changed only on SCLK rising edges; data are latched or read by the master and slave on SCLK falling edges. Details of the SPI communication protocol employed by the ADS1220 can be found in the [SPI Timing Characteristics](#). TI recommends to place 47-Ω resistors in series with all digital input pins ( $\overline{CS}$ , SCLK, and DIN). This resistance smooths sharp transitions, suppresses overshoot, and offers some overvoltage protection. Care must be taken to still meet all SPI timing requirements because the additional resistors interact with the bus capacitances present on the digital signal lines.

Good power-supply decoupling is important to achieve optimum performance. Both AVDD and DVDD should be decoupled with at least a 0.1-μF bypass capacitor each. The bypass capacitors should be placed as close to the power-supply pins as possible with a low impedance connection. For very sensitive systems, or systems in harsh noise environments, avoiding the use of vias for connecting the bypass capacitor may offer superior bypass and noise immunity.

TI recommends employing best design practices when laying out a printed circuit board (PCB) for both analog and digital components. This recommendation generally means that the layout should separate analog components [such as ADCs, amplifiers, references, digital-to-analog converters (DACs), and analog MUXs] from digital components [such as microcontrollers, complex programmable logic devices (CPLDs), field-programmable gate arrays (FPGAs), radio frequency (RF) transceivers, universal serial bus (USB) transceivers, and switching regulators]. An example of good component placement is shown in [Figure 67](#). While [Figure 67](#) provides a good example of component placement, the best placement for each application is unique to the geometries, components, and PCB fabrication capabilities employed. That is, there is no single layout that is perfect for every design and careful consideration must always be used when designing with any analog components.



**Figure 67. System Component Placement**

The use of split analog and digital ground planes is not necessary for improved noise performance (although for thermal isolation this option is a worthwhile consideration). However, the use of a solid ground plane or ground fill in PCB areas with no components is essential for optimum performance. If the system being used employs a split digital and analog ground plane, TI generally recommends that the ground planes be connected together as close to the ADS1220 as possible.

TI also strongly recommends that digital components, especially RF portions, be kept as far as practically possible from analog circuitry in a given system. Additionally, minimize the distance that digital control traces run through analog areas and avoid placing these traces near sensitive analog components. Digital return currents usually flow through a ground path that is as close to the digital path as possible. If a solid ground connection to a plane is not available, these currents may find paths back to the source that interfere with analog performance. The implications that layout has on the temperature sensing functions are much more significant than for ADC functions.

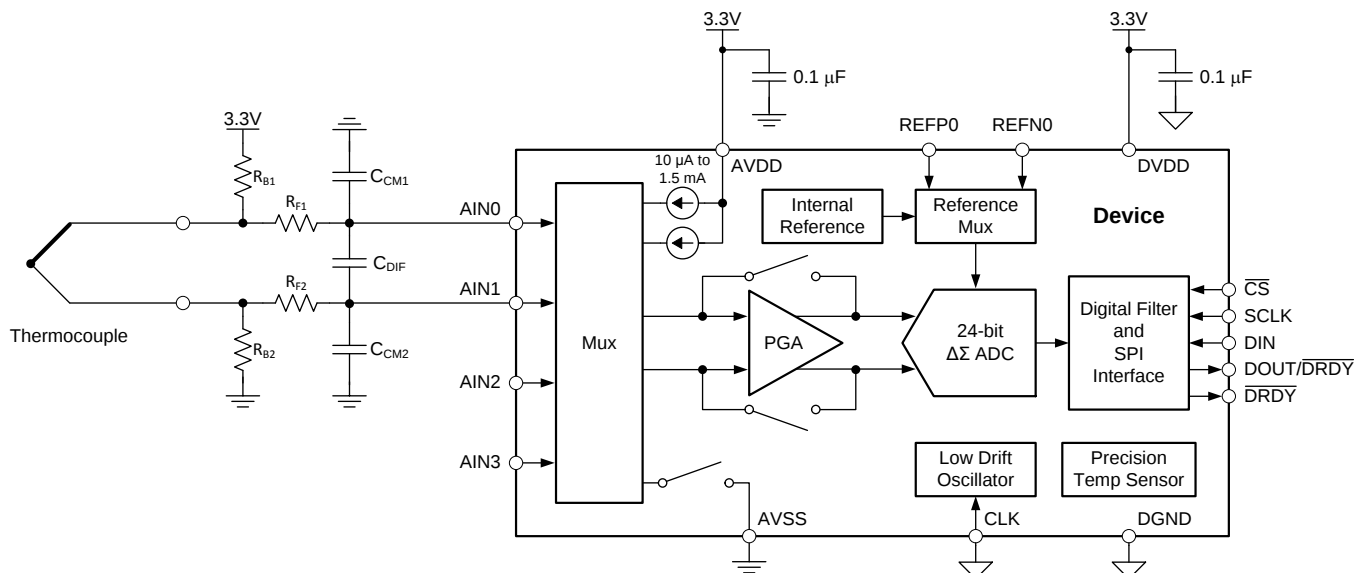
## CONNECTING MULTIPLE DEVICES

When connecting multiple ADS1220 devices to a single SPI bus, SCLK, DIN, and DOUT/DRDY can be safely shared by using a dedicated chip-select ( $\overline{CS}$ ) line for each SPI-enabled device. When  $\overline{CS}$  transitions high for the respective ADS1220, DOUT/DRDY enters a tri-state mode. Therefore, DOUT/DRDY cannot be used to indicate when new data are available if  $\overline{CS}$  is high, regardless if bit DRDYM in the configuration register is set to '0' or '1'. Only the dedicated DRDY pin indicates that new data are available, because the DRDY pin is actively driven even when  $\overline{CS}$  is high.

In some cases, however, the DRDY pin cannot be interfaced to the microcontroller, perhaps because of insufficient GPIO channels on the microcontroller or because the serial interface must be galvanically isolated and thus the amount of channels has to be limited. Therefore, in order to evaluate when a new conversion of one of the devices is ready, the microcontroller can periodically drop  $\overline{CS}$  to the respective ADS1220. When  $\overline{CS}$  goes low, the DOUT/DRDY pin immediately drives either high or low, provided that bit DRDYM is configured to '1'. If the DOUT/DRDY line drives low on a low  $\overline{CS}$ , new data are currently available for clocking out. If the DOUT/DRDY line drives high, no new data are available. Alternatively, valid data can be retrieved from the ADS1220 at any time without concern of data corruption by using the RDATA command.

## THERMOCOUPLE MEASUREMENT

Figure 68 shows the basic connections of a thermocouple measurement system, using the internal high-precision temperature sensor for cold-junction compensation. Apart from the thermocouple itself, the only external circuitry required are two biasing resistors, a simple low-pass, antialiasing filter, and the power-supply decoupling capacitors.



**Figure 68. Thermocouple Measurement**

The biasing resistors  $R_{B1}$  and  $R_{B2}$  are used to set the common-mode voltage of the thermocouple to within the specified common-mode voltage range of the PGA (in this example, to mid-supply  $AVDD / 2$ ). In case the application requires the thermocouple to be biased to GND, a bipolar supply (for example,  $AVSS = -2.5\text{ V}$  and  $AVDD = +2.5\text{ V}$ ) must be used for the ADS1220 to meet the common-mode voltage requirement. When choosing the values of the biasing resistors, care must be taken so that the biasing current does not degrade measurement accuracy. The biasing current flows through the thermocouple where it can cause self-heating and additional voltage drops in the thermocouple leads.

In addition to biasing the thermocouple,  $R_{B1}$  and  $R_{B2}$  are also useful to detect an open thermocouple lead. When one of the thermocouple leads fails open, the biasing resistors pull the analog inputs AIN0 and AIN1 to  $AVDD$  and  $AVSS$ , respectively. The ADC consequently reads a full-scale value, which is outside the normal measurement range of the thermocouple voltage, to indicate this failure condition.

While the digital filter of the ADS1220 attenuates high-frequency components of noise, TI generally recommends providing a first-order, passive RC filter at the inputs to further improve performance. The differential RC filter formed by  $R_{F1}$ ,  $R_{F2}$  and the differential capacitor  $C_{DIF}$  offers a cutoff frequency of  $f_c = 1 / (2\pi \times R_{F1} \times C_{DIF})$ . Two common-mode filter capacitors  $C_{M1}$  and  $C_{M2}$  are also added to offer attenuation of high-frequency common-mode noise components. Because mismatches in the common-mode capacitors cause differential noise, TI recommends that the differential capacitor  $C_{DIF}$  be at least an order of magnitude (10x) larger than the common-mode capacitors  $C_{M1}$  and  $C_{M2}$ .

The filter resistors  $R_{F1}$  and  $R_{F2}$  also serve as current-limiting resistors. These resistors limit the current into the analog inputs (AIN0 and AIN1) of the ADS1220 to safe levels, should an overvoltage on the inputs occur. TI recommends limiting the filter resistor values to below 1 k $\Omega$ . Larger filter resistor values can lead to additional offset errors because of the voltage drops across them caused by the differential input currents of the ADS1220.

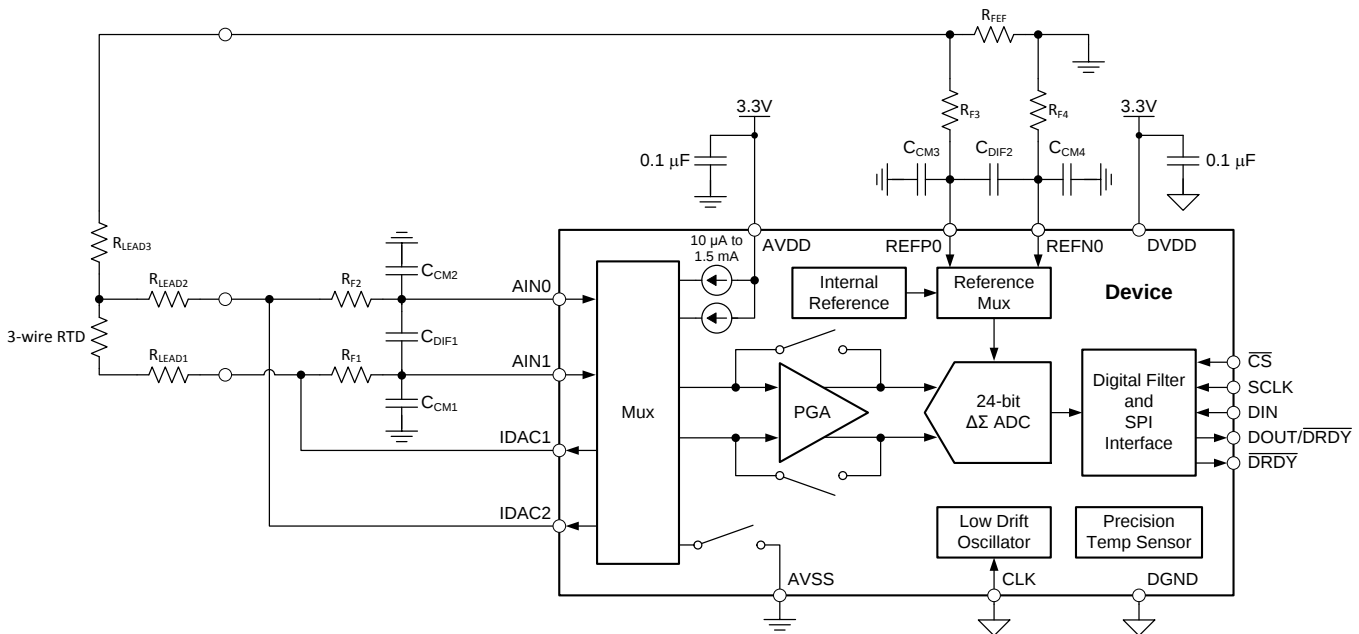
The ADS1220 integrates a high-precision temperature sensor that can be used to measure the temperature of the cold junction. To measure the internal temperature of the ADS1220, the device must be set to internal temperature sensor mode by setting bit TS to '1' in the configuration register. For best performance, careful board layout is critical to achieve good thermal conductivity between the cold junction and the ADS1220 package.

However, the ADS1220 does not perform automatic cold-junction compensation of the thermocouple. This compensation must be done in the microcontroller that interfaces to the ADS1220. The microcontroller requests one or multiple readings of the thermocouple voltage from the ADS1220 and then sets the device to internal temperature sensor mode (TS = 1) to acquire the temperature of the cold junction. The calculations to compensate for the cold-junction temperature must be implemented on the microcontroller.

In some applications, the integrated temperature sensor cannot be used (for example, if the accuracy is not high enough or if the ADS1220 cannot be placed close enough to the cold junction). The additional analog input channels of the ADS1220 can be used in this case to measure the cold-junction temperature using a thermistor or RTD.

## RTD MEASUREMENT

The ADS1220 integrates all necessary features (such as dual-matched programmable current sources, buffered reference inputs, PGA, and so forth) to ease the implementation of ratiometric 2-, 3-, and 4-wire RTD measurements. Figure 69 shows a typical implementation of a ratiometric 3-wire RTD measurement using the excitation current sources integrated in the ADS1220 to excite the RTD as well as to implement automatic RTD lead-resistance compensation.



**Figure 69. 3-Wire RTD Measurement**

The circuit in Figure 69 employs a ratiometric measurement approach. In other words, the sensor signal (that is the voltage across the RTD in this case) and the reference voltage for the ADC are derived from the same excitation source. Therefore, errors resulting from temperature drift or noise cancel out because these errors are common to both the sensor signal and the reference.

In order to implement a ratiometric 3-wire RTD measurement using the ADS1220, IDAC1 is routed to one of the excitation leads of the RTD while IDAC2 is routed to the second excitation lead. Both currents have the same value, which is programmable by bits IDAC[2:0] in the configuration register. The design of the ADS1220 ensures that both IDAC values are closely matched, even across temperature. The sum of both currents flows through a low-drift reference resistor,  $R_{REF}$ . The voltage,  $V_{REF}$ , generated across the reference resistor is as shown in Equation 7. Because  $IDAC1 = IDAC2$ , Equation 8 is then used as the ADC reference voltage.

$$V_{REF} = (IDAC1 + IDAC2) \times R_{REF} \quad (7)$$

$$V_{REF} = 2 \times IDAC1 \times R_{REF} \quad (8)$$

**Equation 9** assumes for the moment that the individual lead resistance values of the RTD ( $R_{LEADx}$ ) are zero. Only IDAC1 excites the RTD to produce a voltage  $V_{RTD}$ , which is proportional to the temperature dependable RTD value and the IDAC1 value.

$$V_{RTD} = R_{RTD} (\text{Temperature}) \times I_{IDAC1} \quad (9)$$

The ADS1220 internally amplifies the voltage across the RTD using the PGA and compares the resulting voltage against the reference voltage to produce a digital output code, which is proportional to **Equation 10** to **Equation 12**:

$$\text{Code} \propto V_{RTD} \times \text{PGA} / V_{REF} \quad (10)$$

$$\text{Code} \propto [R_{RTD} (\text{Temperature}) \times I_{IDAC1} \times \text{PGA}] / [2 \times IDAC1 \times R_{REF}] \quad (11)$$

$$\text{Code} \propto [R_{RTD} (\text{Temperature}) \times \text{PGA}] / [2 \times R_{REF}] \quad (12)$$

As can be seen from **Equation 12**, the output code only depends on the value of the RTD, the PGA gain and the reference resistor ( $R_{REF}$ ), but not on the IDAC1 value. The absolute accuracy and temperature drift of the excitation current therefore does not matter. However, because the value of the reference resistor directly impacts the measurement result, choosing a reference resistor with a very low temperature coefficient is important to limit errors introduced by the temperature drift of  $R_{REF}$ .

The second IDAC2 is used to compensate for errors introduced by the voltage drop across the lead resistance of the RTD. All three leads of a 3-wire RTD typically have the same length and, thus, the same lead resistance. Also, IDAC1 and IDAC2 have the same value. Consequently, the differential voltage ( $V_{IN}$ ) across the ADC inputs, AIN0 and AIN1, is as shown in **Equation 13**:

$$V_{IN} = V_{AIN0} - V_{AIN1} = I_{IDAC1} \times (R_{RTD} + R_{LEAD1}) - I_{IDAC2} \times R_{LEAD2} \quad (13)$$

When  $R_{LEAD1} = R_{LEAD2}$  and  $I_{IDAC1} = I_{IDAC2}$ , **Equation 13** reduces to **Equation 14**:

$$V_{IN} = I_{IDAC1} \times R_{RTD} \quad (14)$$

In other words, the measurement error resulting from the voltage drop across the RTD lead resistance is compensated, as long as the lead resistance values and the IDAC values are well matched.

A first-order differential and common-mode RC filter ( $R_{F1}$ ,  $R_{F2}$ ,  $C_{DIF1}$ ,  $C_{CM1}$ ,  $C_{CM2}$ ) is placed on the ADC inputs, as well as on the reference inputs ( $R_{F3}$ ,  $R_{F4}$ ,  $C_{DIF2}$ ,  $C_{CM3}$ ,  $C_{CM4}$ ). The same guidelines for designing the input filter apply as described in the **Thermocouple Measurement** section. For best performance, TI recommends to match the corner frequencies of the input and reference filter. More detailed information on matching the input and reference filter can be found in application report **RTD Ratiometric Measurements and Filtering Using the ADS1148 and ADS1248 (SBAA201)**.

The reference resistor  $R_{REF}$  not only serves to generate the reference voltage for the ADS1220, but also sets the common-mode voltage of the RTD to within the specified common-mode voltage range of the PGA. In other words, the voltage across the reference resistor must meet **Equation 5**.

When designing the circuit, care should also be taken to meet the compliance voltage requirement of the IDACs. The IDACs require a minimum headroom of ( $AVDD - 0.9 \text{ V}$ ) in order to operate accurately. This requirement means that **Equation 15** must be met at all times.

$$AVSS + I_{IDAC1} \times (R_{LEAD1} + R_{RTD}) + (I_{IDAC1} + I_{IDAC2}) \times (R_{LEAD3} + R_{REF}) \leq AVDD - 0.9 \text{ V} \quad (15)$$

The ADS1220 also offers the possibility to route the IDACs to the same inputs used for measurement. In case the filter resistor values  $R_{F1}$  and  $R_{F2}$  are small enough and well matched, IDAC1 can be routed to AIN1 and IDAC2 to AIN0, respectively, in **Figure 69**. In this manner, even two 3-wire RTDs sharing the same reference resistor can be measured with a single ADS1220.

Implementing a 2- or 4-wire RTD measurement is very similar to the 3-wire RTD measurement shown in **Figure 69** except that only one IDAC is required.

## HIGH-LEVEL CODE EXAMPLE

The following list shows a high-level code sequence with steps necessary to set up the ADS1220 and the microcontroller interfacing to it, in order to take subsequent readings from the ADS1220 in continuous conversion mode. The dedicated DRDY pin is used to indicate availability of new conversion data. The default configuration register settings are changed to PGA = 16, continuous conversion mode, and simultaneous 50-Hz and 60-Hz rejection.

- Power-up
- Delay
- Configure the SPI interface of the microcontroller to SPI mode 1
- If the  $\overline{\text{CS}}$  pin is not tied low permanently, configure the microcontroller GPIO connected to  $\overline{\text{CS}}$  as an output
- Configure the microcontroller GPIO connected to the DRDY pin as an interrupt input
- Set  $\overline{\text{CS}}$  to the ADS1220 low
- Delay
- Send the RESET command (06h) to make sure the ADS1220 is properly reset after power-up
- Write the respective register configuration using the WREG command (43h, 08h, 04h, 10h, and 00h)
- Delay
- Read back all configuration registers using the RREG command (23h) to make sure the correct values are written
- Delay
- Send the START/SYNC command (08h) to start converting in continuous conversion mode
- Delay
- Clear  $\overline{\text{CS}}$  to high (resets the serial interface)
- Loop
  - {
  - Wait for DRDY to transition low
  - Take  $\overline{\text{CS}}$  low
  - Delay
  - Send 24 SCLK rising edges to read out conversion data on DOUT
  - Delay
  - Clear  $\overline{\text{CS}}$  to high
  - }
- Take  $\overline{\text{CS}}$  low
- Delay
- Send the POWERDOWN command (02h) to stop conversions and put the ADS1220 in power-down mode
- Delay
- Clear  $\overline{\text{CS}}$  to high

TI recommends running an offset calibration before performing any measurements or when changing the gain of the PGA. The internal offset of the ADS1220 can, for example, be measured by shorting the inputs to mid-supply (MUX[3:1] = 1110). The microcontroller then takes multiple readings from the ADS1220 with the inputs shorted and stores the average value in the microcontroller memory. When measuring the sensor signal, the microcontroller then subtracts the stored offset value from each ADS1220 reading to get an offset compensated result.

## REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Original (May 2013) to Revision A                                                                                   | Page              |
|----------------------------------------------------------------------------------------------------------------------------------|-------------------|
| <ul style="list-style-type: none"> <li>Changed document status to Mixed Status; pre-RTM changes made throughout .....</li> </ul> | <a href="#">1</a> |

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)            | Lead/Ball Finish<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|----------------------|--------------|-------------------------|-------------------------|
| ADS1220IPW       | ACTIVE        | TSSOP        | PW                 | 16   | 90             | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-2-260C-1 YEAR  | -40 to 125   | ADS1220                 | <a href="#">Samples</a> |
| ADS1220IPWR      | ACTIVE        | TSSOP        | PW                 | 16   | 2500           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-2-260C-1 YEAR  | -40 to 125   | ADS1220                 | <a href="#">Samples</a> |
| ADS1220IRVAR     | ACTIVE        | VQFN         | RVA                | 16   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-2-260C-1 YEAR  | -40 to 125   | 1220                    | <a href="#">Samples</a> |
| ADS1220IRVAT     | ACTIVE        | VQFN         | RVA                | 16   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU               | Level-2-260C-1 YEAR  | -40 to 125   | 1220                    | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBsolete:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

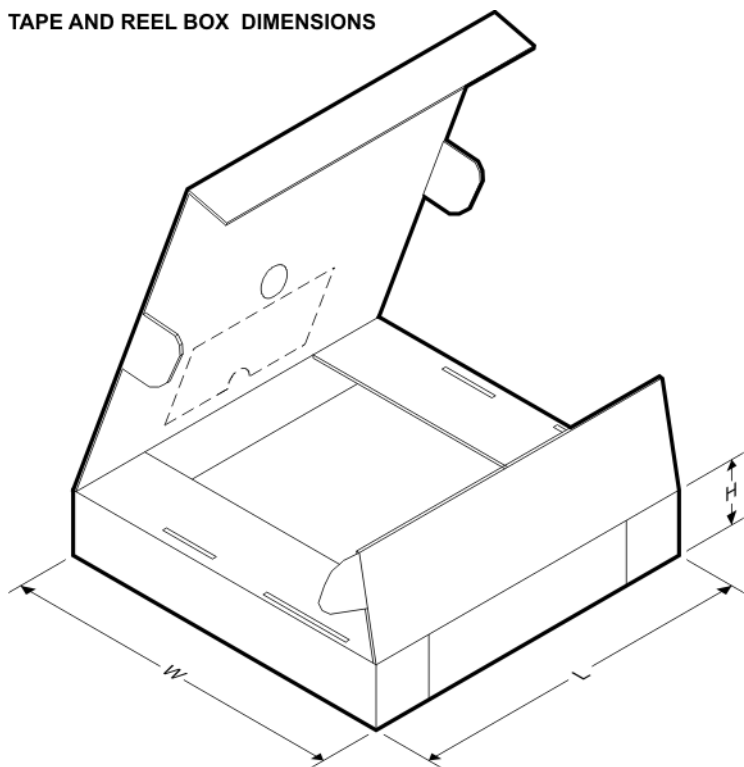
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ADS1220IPWR  | TSSOP        | PW              | 16   | 2500 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| ADS1220IRVAR | VQFN         | RVA             | 16   | 3000 | 330.0              | 12.4               | 3.75    | 3.75    | 1.15    | 8.0     | 12.0   | Q1            |
| ADS1220IRVAT | VQFN         | RVA             | 16   | 250  | 180.0              | 12.4               | 3.75    | 3.75    | 1.15    | 8.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS

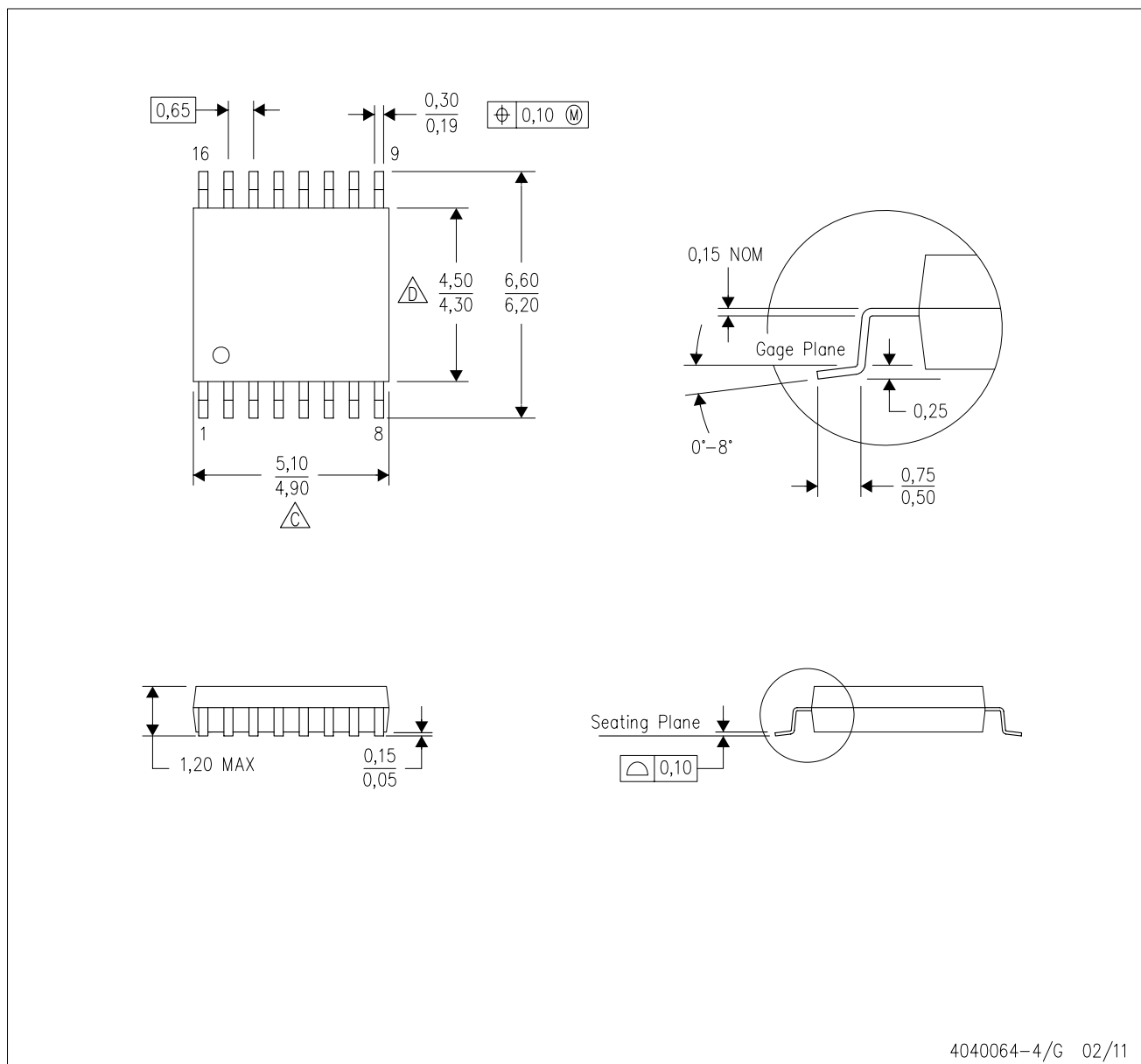


\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS1220IPWR  | TSSOP        | PW              | 16   | 2500 | 367.0       | 367.0      | 35.0        |
| ADS1220IRVAR | VQFN         | RVA             | 16   | 3000 | 367.0       | 367.0      | 35.0        |
| ADS1220IRVAT | VQFN         | RVA             | 16   | 250  | 210.0       | 185.0      | 35.0        |

PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE

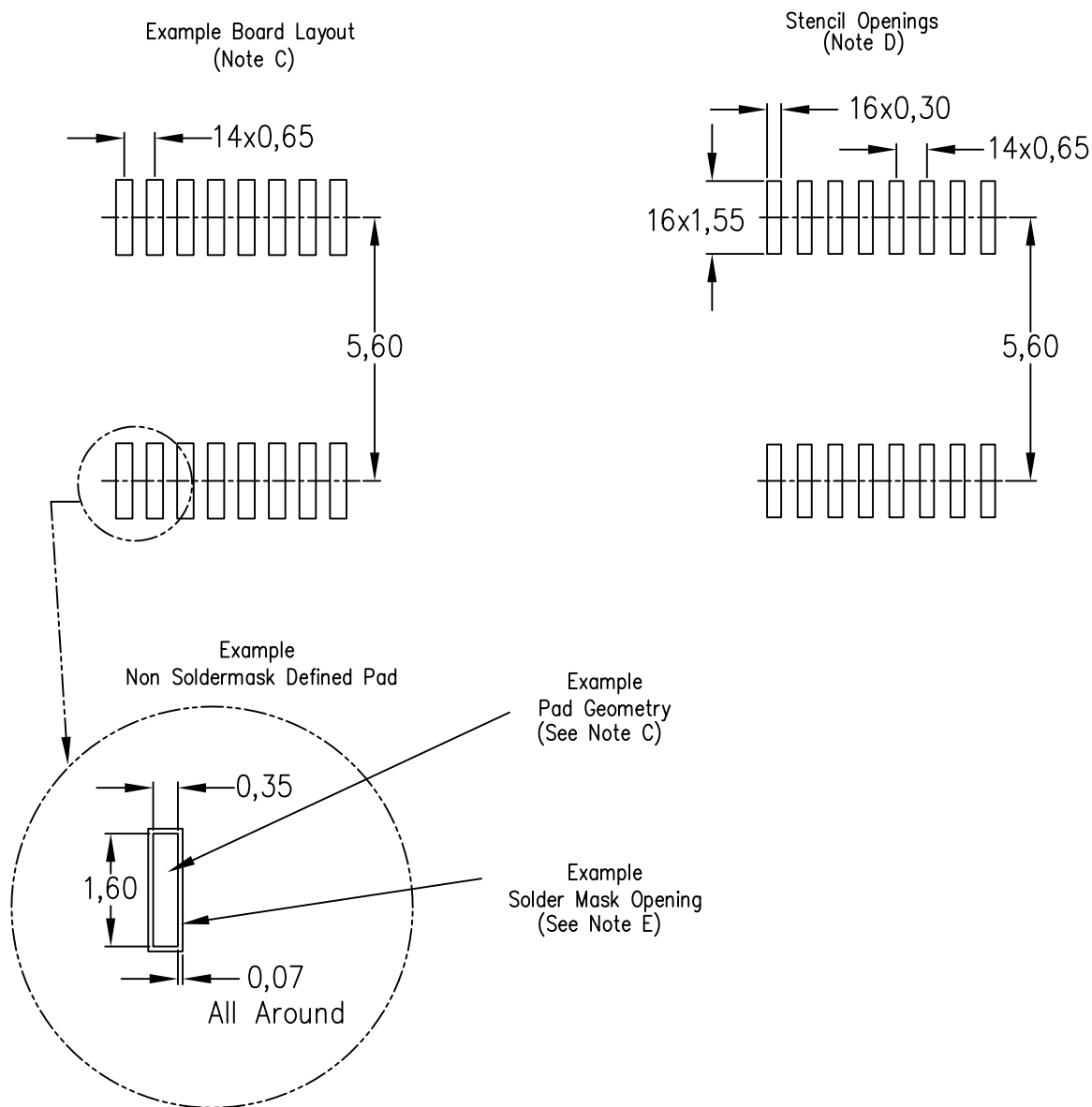


4040064-4/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE

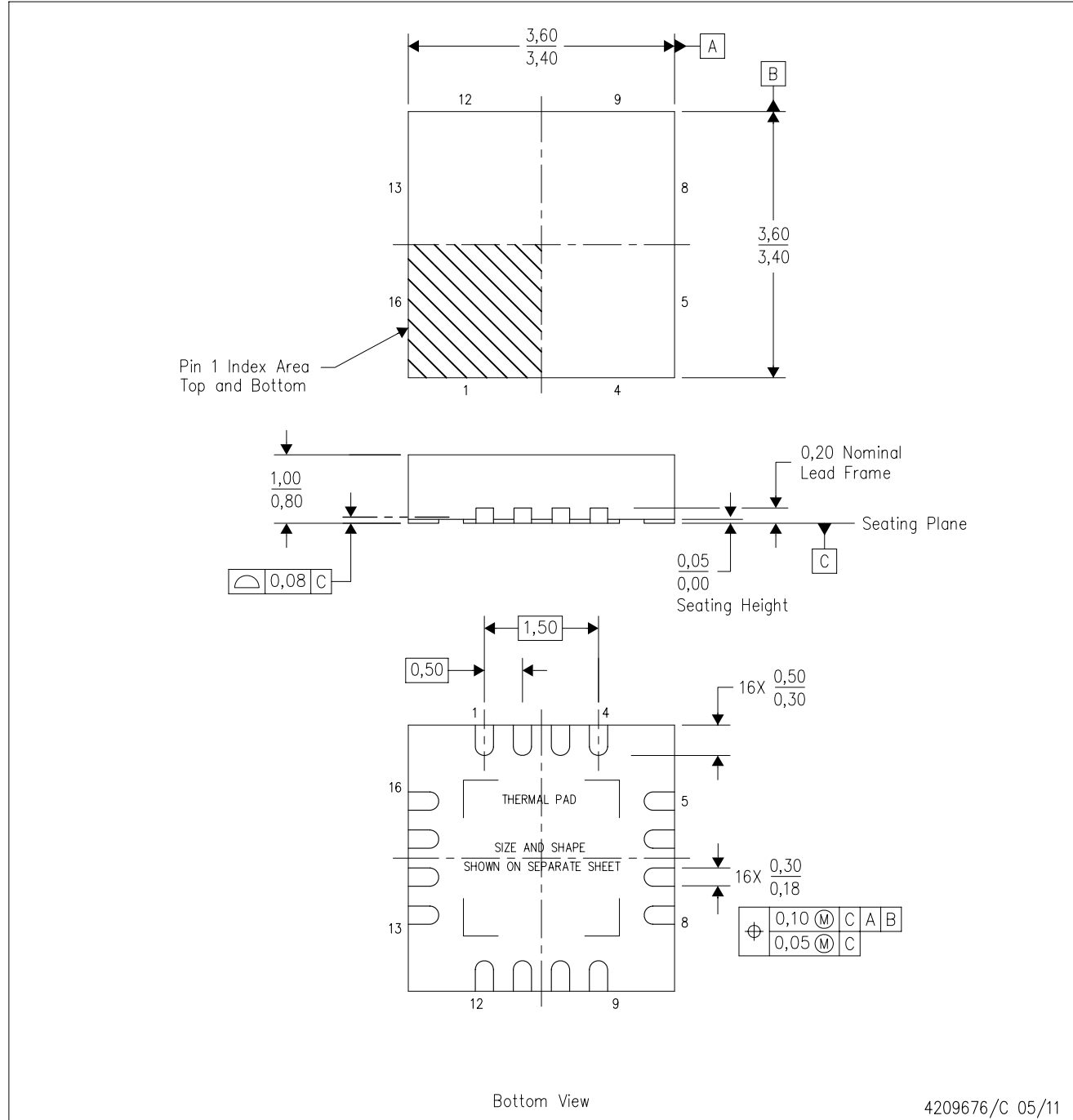


4211284-3/F 12/12

- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

RVA (S-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. QFN (Quad Flatpack No-Lead) package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.

RVA (S-PVQFN-N16)

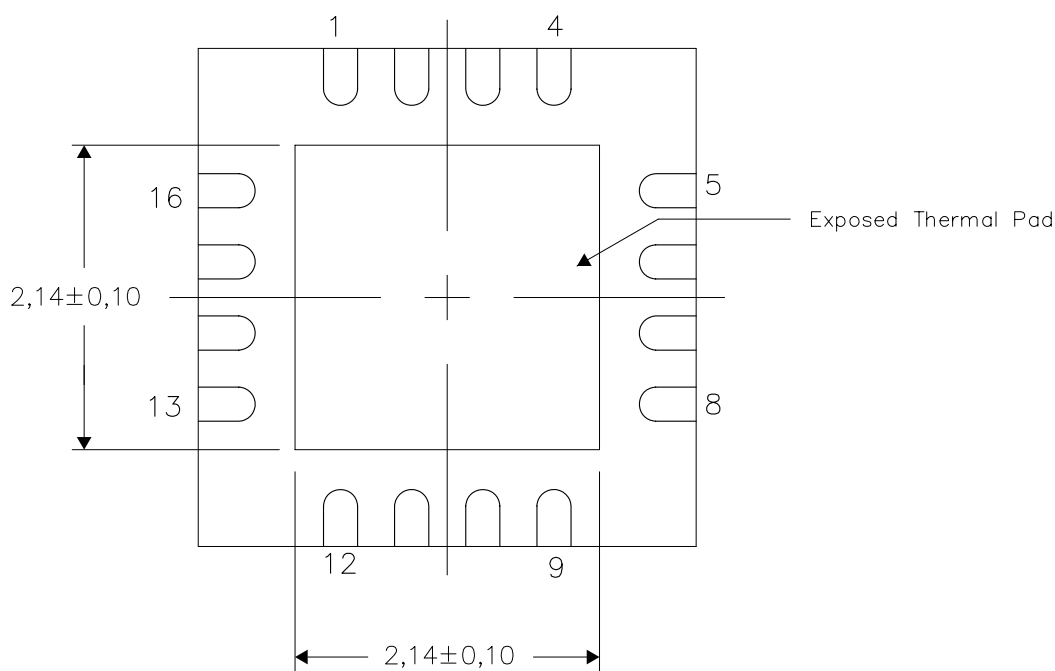
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

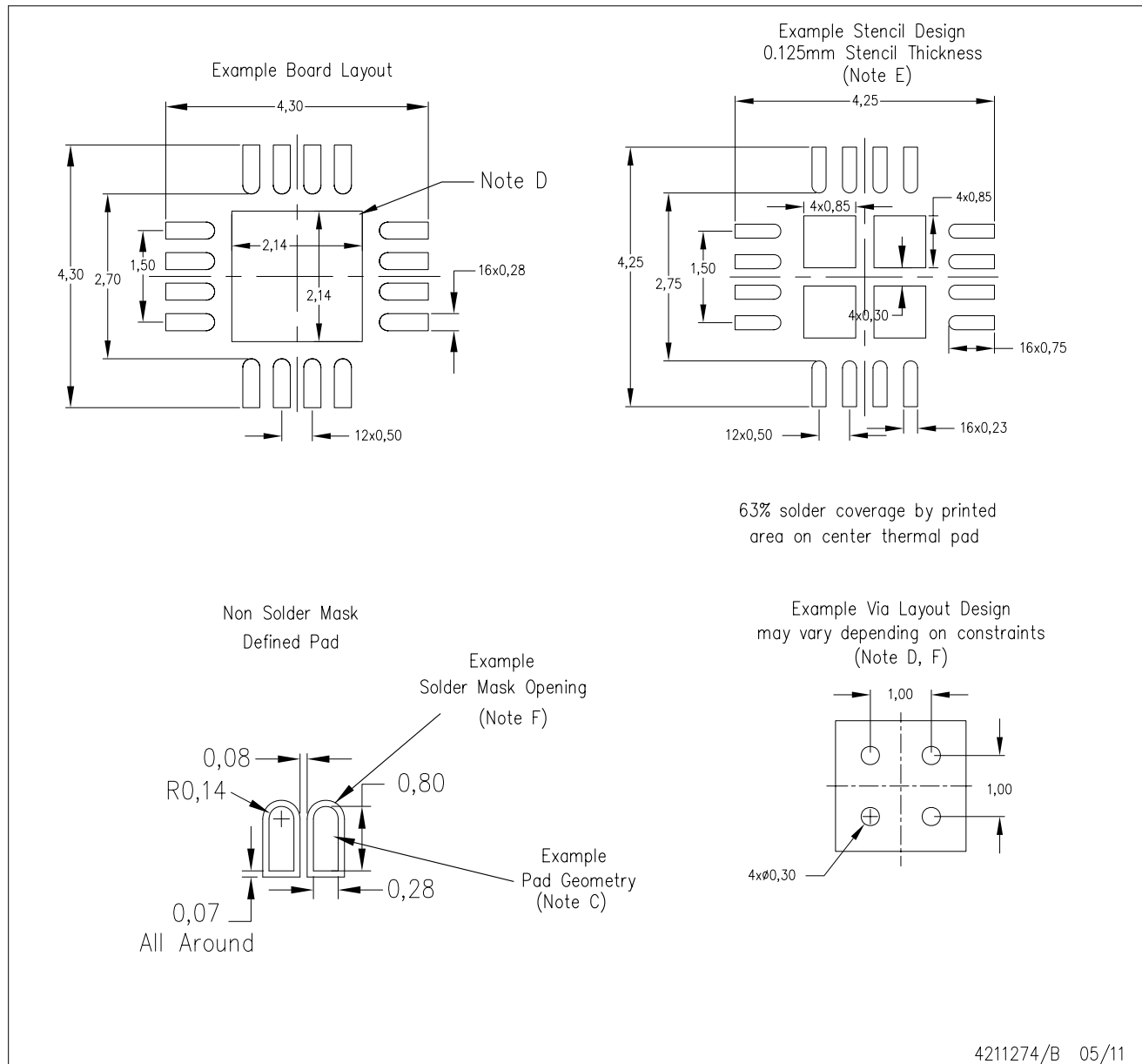
Exposed Thermal Pad Dimensions

4209715/B 05/11

NOTE: All linear dimensions are in millimeters

RVA (S-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

### Products

|                              |                                                                                      |
|------------------------------|--------------------------------------------------------------------------------------|
| Audio                        | <a href="http://www.ti.com/audio">www.ti.com/audio</a>                               |
| Amplifiers                   | <a href="http://amplifier.ti.com">amplifier.ti.com</a>                               |
| Data Converters              | <a href="http://dataconverter.ti.com">dataconverter.ti.com</a>                       |
| DLP® Products                | <a href="http://www.dlp.com">www.dlp.com</a>                                         |
| DSP                          | <a href="http://dsp.ti.com">dsp.ti.com</a>                                           |
| Clocks and Timers            | <a href="http://www.ti.com/clocks">www.ti.com/clocks</a>                             |
| Interface                    | <a href="http://interface.ti.com">interface.ti.com</a>                               |
| Logic                        | <a href="http://logic.ti.com">logic.ti.com</a>                                       |
| Power Mgmt                   | <a href="http://power.ti.com">power.ti.com</a>                                       |
| Microcontrollers             | <a href="http://microcontroller.ti.com">microcontroller.ti.com</a>                   |
| RFID                         | <a href="http://www.ti-rfid.com">www.ti-rfid.com</a>                                 |
| OMAP Applications Processors | <a href="http://www.ti.com/omap">www.ti.com/omap</a>                                 |
| Wireless Connectivity        | <a href="http://www.ti.com/wirelessconnectivity">www.ti.com/wirelessconnectivity</a> |

### Applications

|                               |                                                                                          |
|-------------------------------|------------------------------------------------------------------------------------------|
| Automotive and Transportation | <a href="http://www.ti.com/automotive">www.ti.com/automotive</a>                         |
| Communications and Telecom    | <a href="http://www.ti.com/communications">www.ti.com/communications</a>                 |
| Computers and Peripherals     | <a href="http://www.ti.com/computers">www.ti.com/computers</a>                           |
| Consumer Electronics          | <a href="http://www.ti.com/consumer-apps">www.ti.com/consumer-apps</a>                   |
| Energy and Lighting           | <a href="http://www.ti.com/energy">www.ti.com/energy</a>                                 |
| Industrial                    | <a href="http://www.ti.com/industrial">www.ti.com/industrial</a>                         |
| Medical                       | <a href="http://www.ti.com/medical">www.ti.com/medical</a>                               |
| Security                      | <a href="http://www.ti.com/security">www.ti.com/security</a>                             |
| Space, Avionics and Defense   | <a href="http://www.ti.com/space-avionics-defense">www.ti.com/space-avionics-defense</a> |
| Video and Imaging             | <a href="http://www.ti.com/video">www.ti.com/video</a>                                   |

### TI E2E Community

[e2e.ti.com](http://e2e.ti.com)